

## **Spatially Resolved Acoustic Spectroscopy (SRAS)**

### ***“Sight Through Sound”***

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DURIP N00014-17-1-2294

# Baseline: this is a microscope

Leeuwenhoek's work defined our definition: *To see small...*

- A more complete technical description of a microscope is:
  - An instrument which
    - uses optics to direct a beam of EM radiation to
    - a specimen that is of interest where
    - the incident waves are modified by certain characteristics of the specimen
    - and for which the modified waves/particles are directed to a detector for analysis (with it's own signal modification)

# Let's test this

## Optical (including Leeuwenhoeks)

<b>Optics</b>	Uses optics to direct a beam of EM radiation to	Light (coherent or incoherent)
<b>Specimen Damage</b>	a specimen that is of interest where	✓
<b>Image Theory</b>	the incident waves are modified by certain characteristics of the specimen	Reflection Transmission
<b>Detectors</b>	and for which the modified waves/particles are directed to a detector for analysis	✓ (from an observer to detectors)

**SRAS is a microscopy technique that directs energy impulses (typically supplied by a laser) to the specimen, and which are sufficient to interact and generate acoustic waves (of varying modes) which can be measured using sophisticated detectors.**

**Interestingly, this structure (optics, specimen/damage, theory, detectors) are where most microscope developers and users spend all their time.**

# Spatially Resolved Acoustic Spectroscopy

Motivation for the work - *Sometimes, we need data and statistics as the mesoscale!*

“Failure is central to engineering. Every single calculation that an engineer makes is a failure calculation. Successful engineering is all about understanding how things break or fail.”

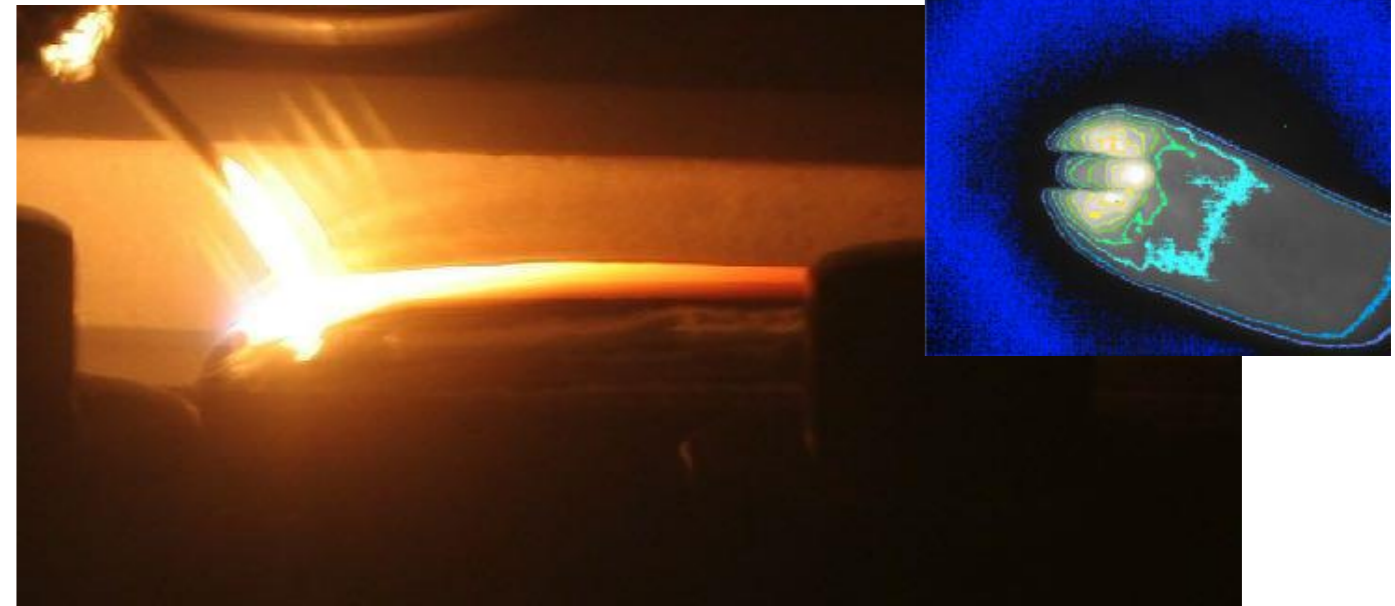
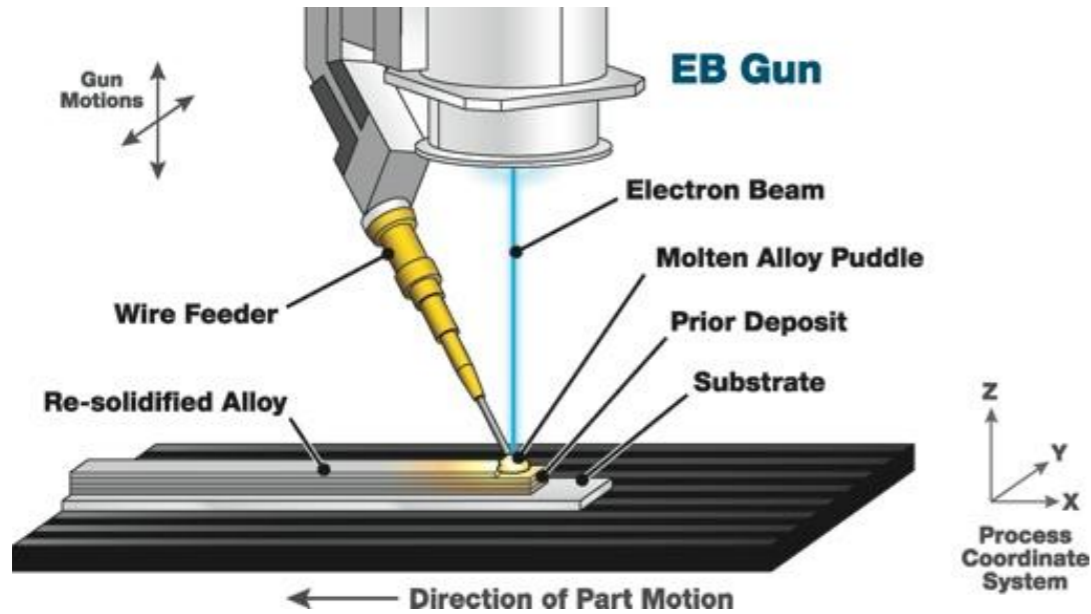
Henry Petroski

SRAS Basics

Our first data

Possibilities, probabilities, and limitations

# Motivation - I (texture in large-scale AM)



2012 AeroMat presentation: "F-35 Direct Manufacturing: Material Qualification Results" June 20, 2012

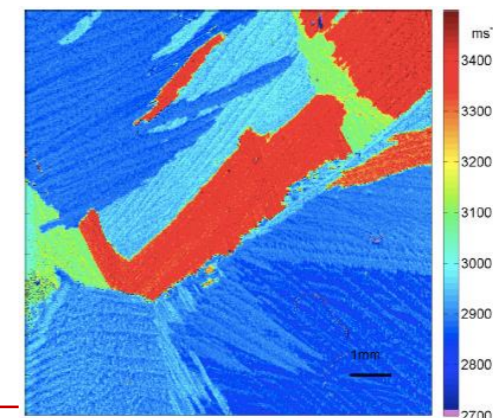
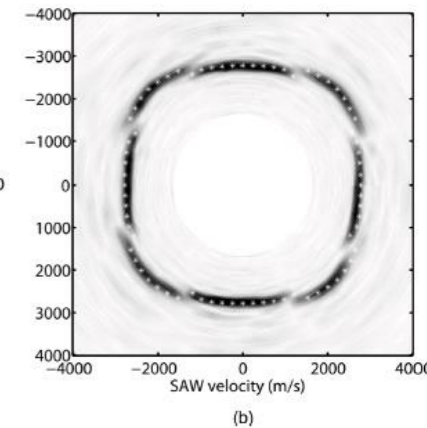
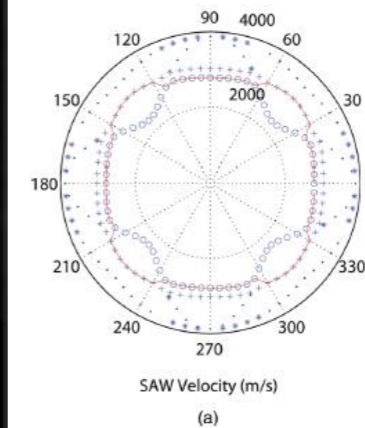
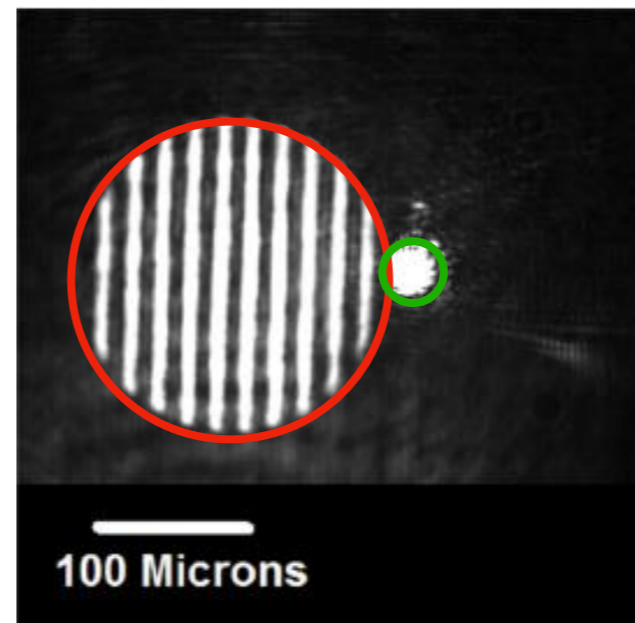
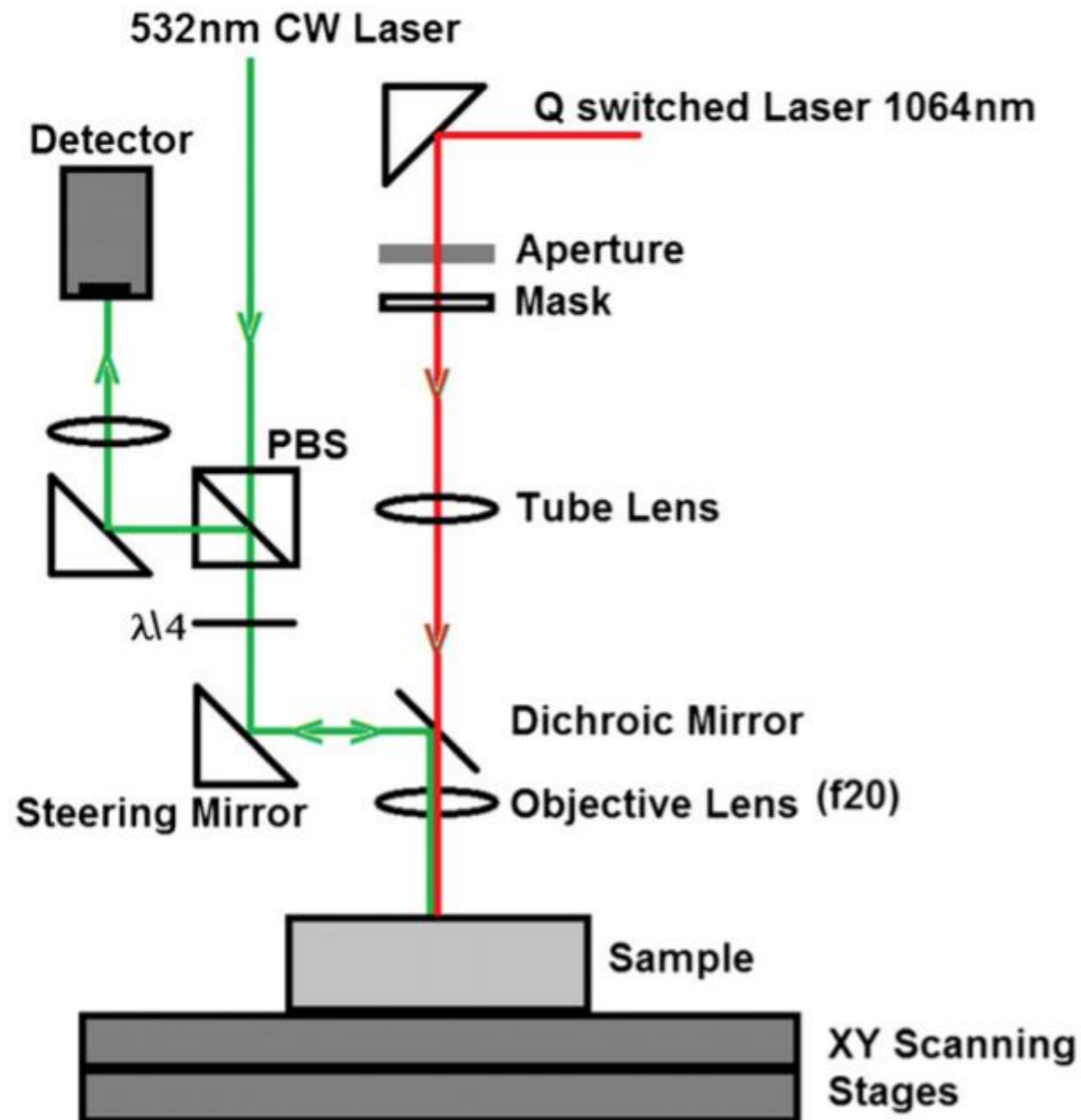


# Motivation and overview - II (microtexture?)



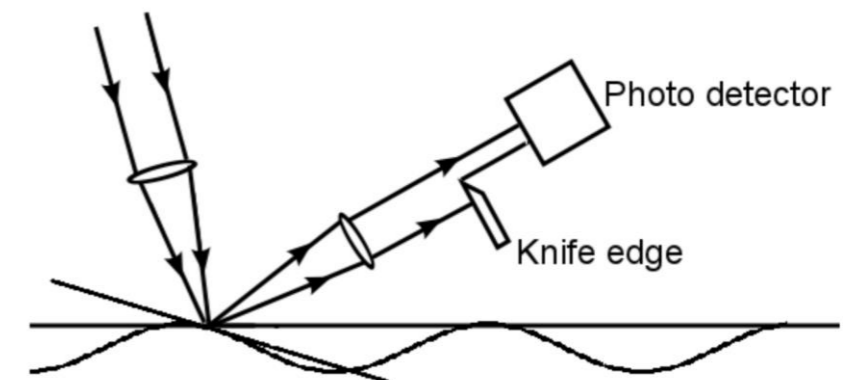
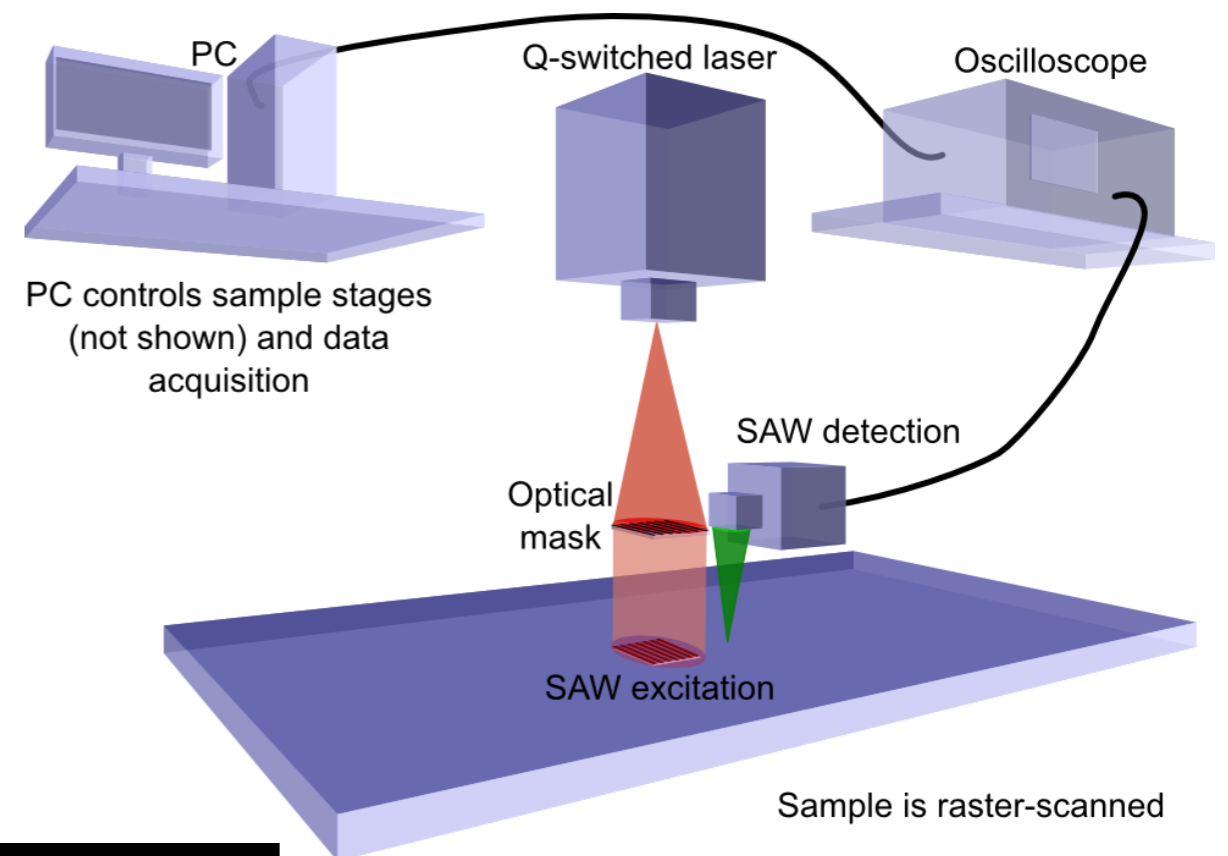
# Spatially Resolved Acoustic Spectroscopy

- Laser UT Technique
- Able to detect velocity of SAWs (*~Mach 9*)
- Can determine crystallographic information through detection of *nm-level surface displacements*
- coupled with simulation of multiple wave modes (governed by the elastic stiffness tensor,  $C_{ijkl}$ )
- EBSD-like data with restrictions



“Spatially resolved acoustic spectroscopy for rapid imaging of material microstructure and grain orientation,” Richard J Smith et al, 2014, Meas. Sci. Technol. **25** 055902 DOI: 10.1088/0957-0233/25/5/055902

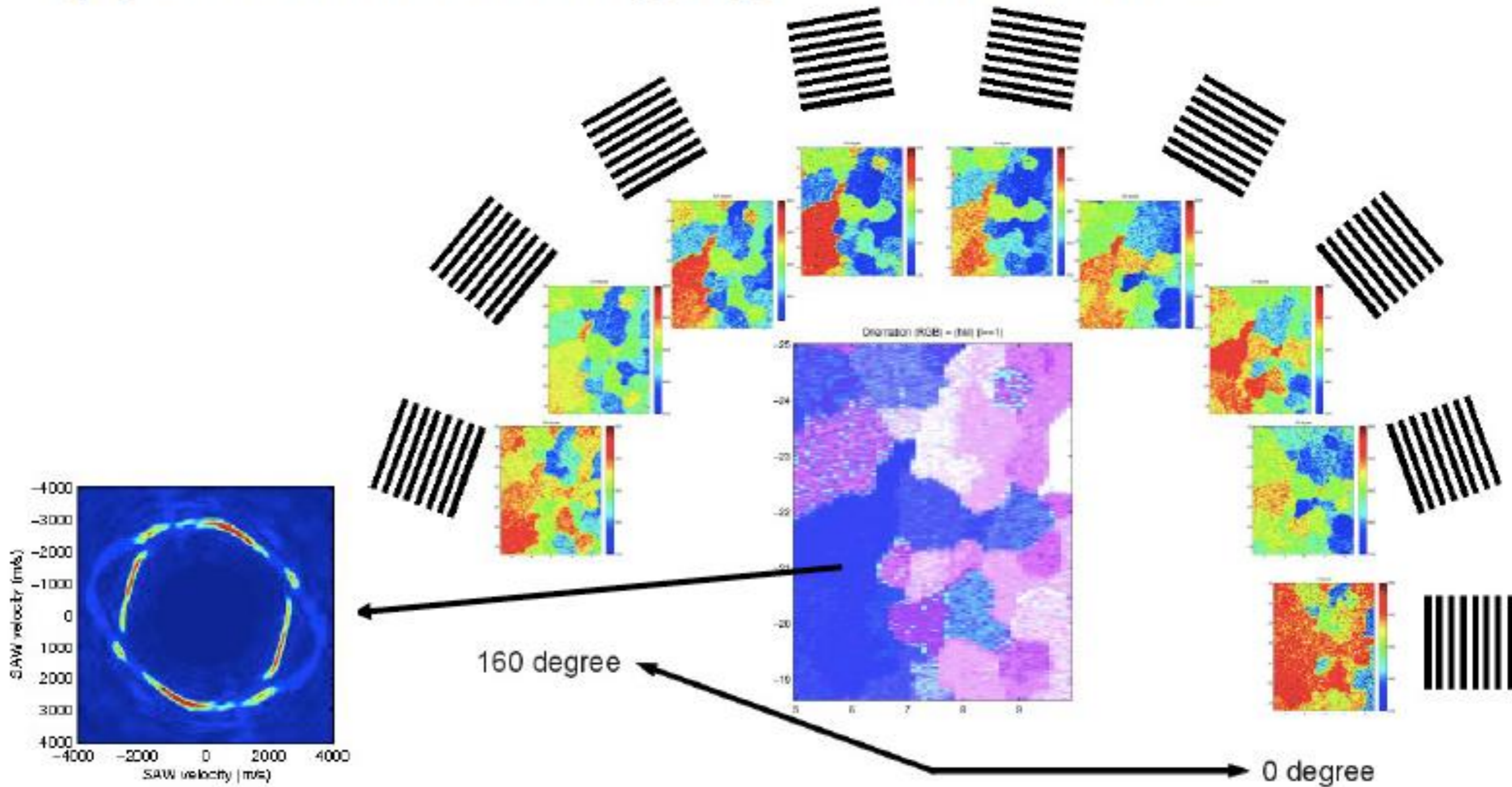
- At each point generate SAWs using *laser* and a *grating* – fixed acoustic wavelength
- Detect the SAWs with another laser
- Find the peak of the frequency spectrum of the detected waves
- Calculate the velocity using  $v = f\lambda$





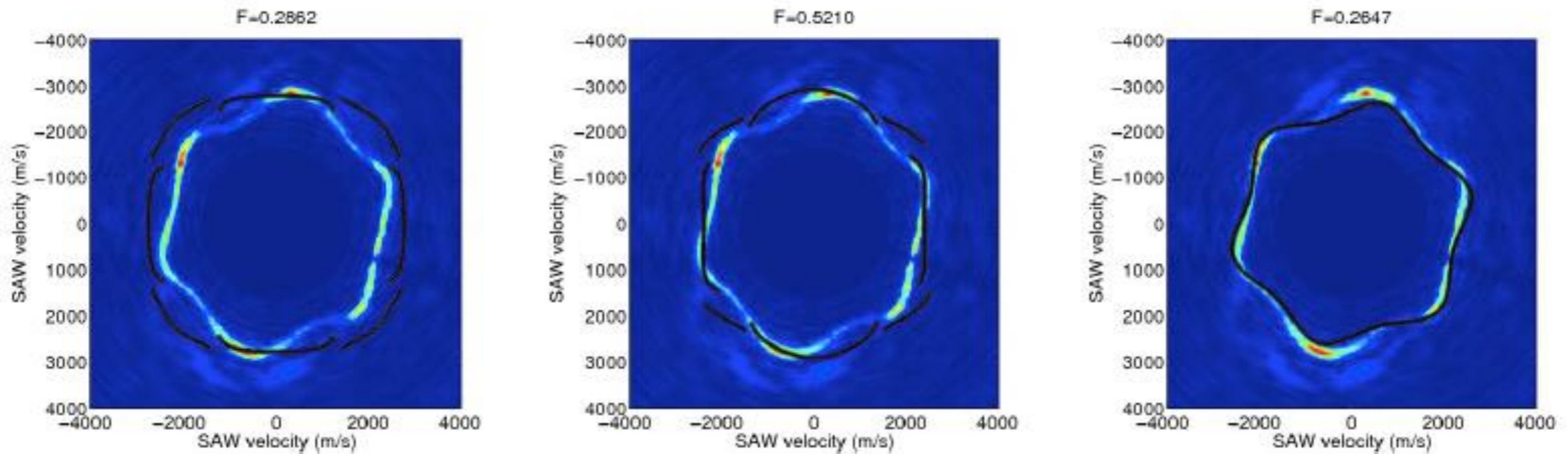
# Orientation Determination in practice

## (2) Orientation imaging – Collect data

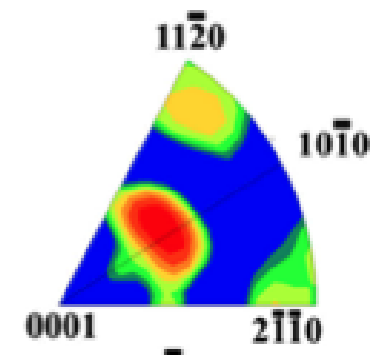
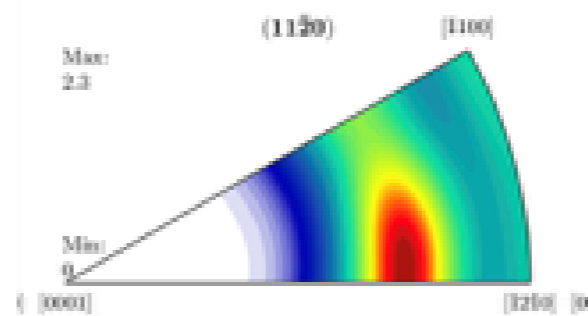
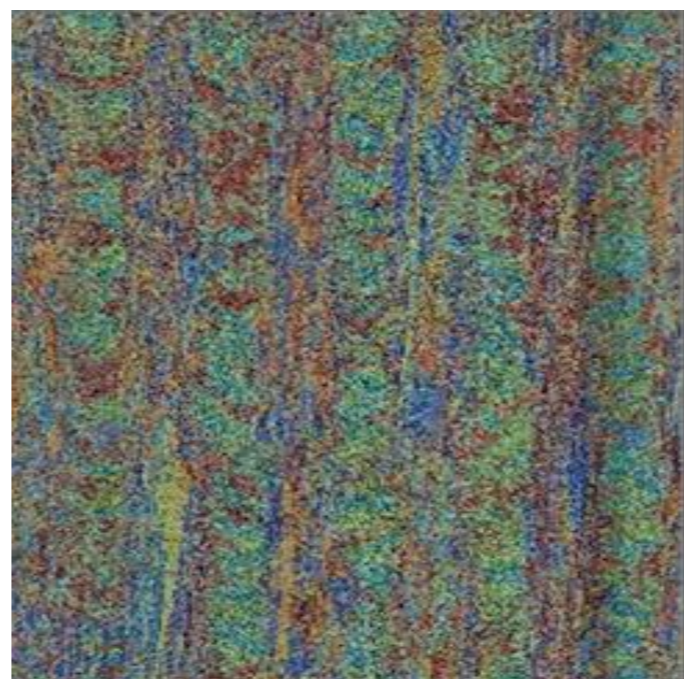
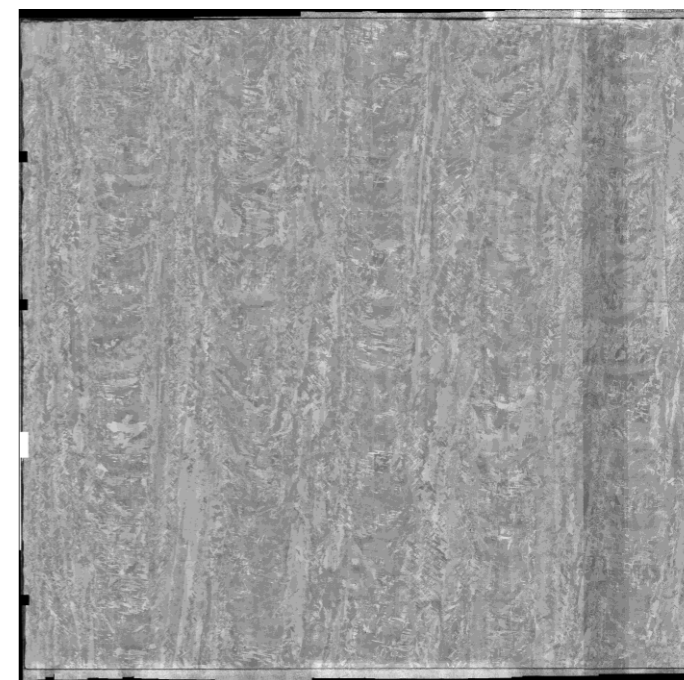
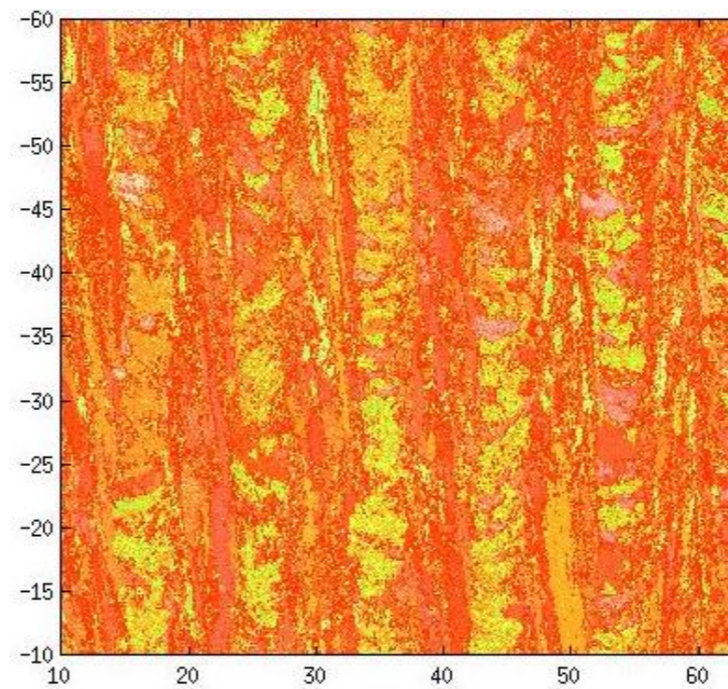
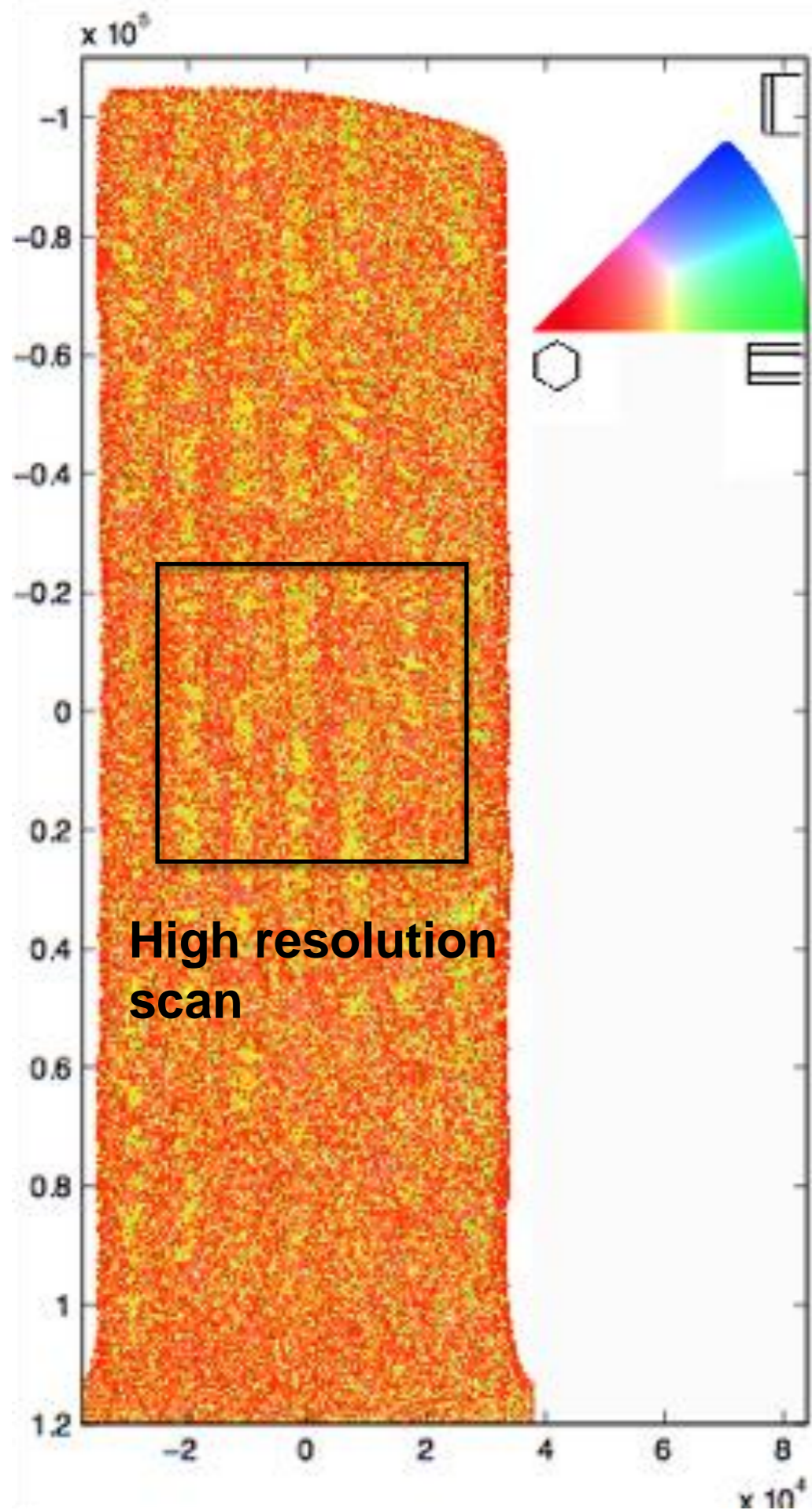


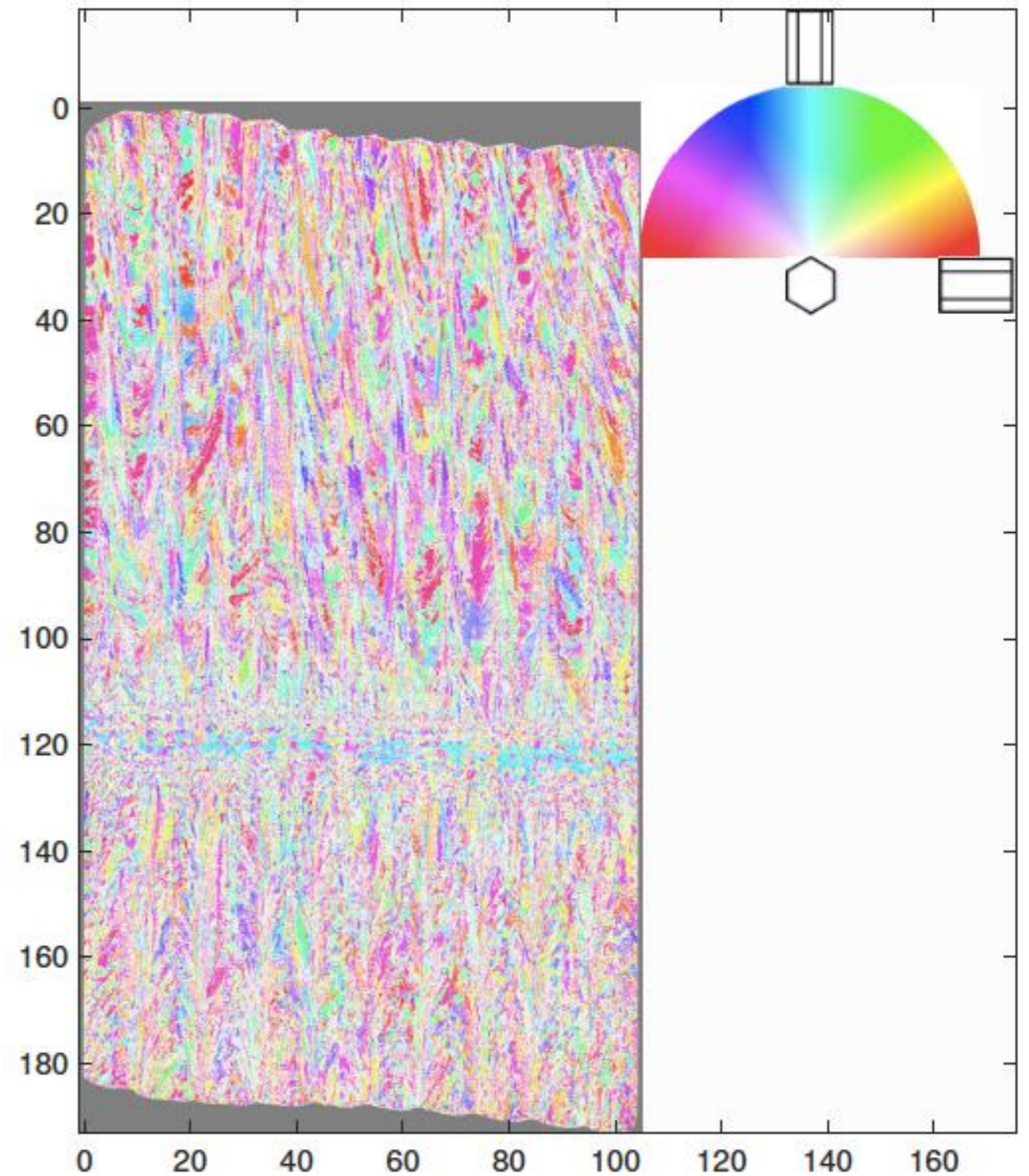
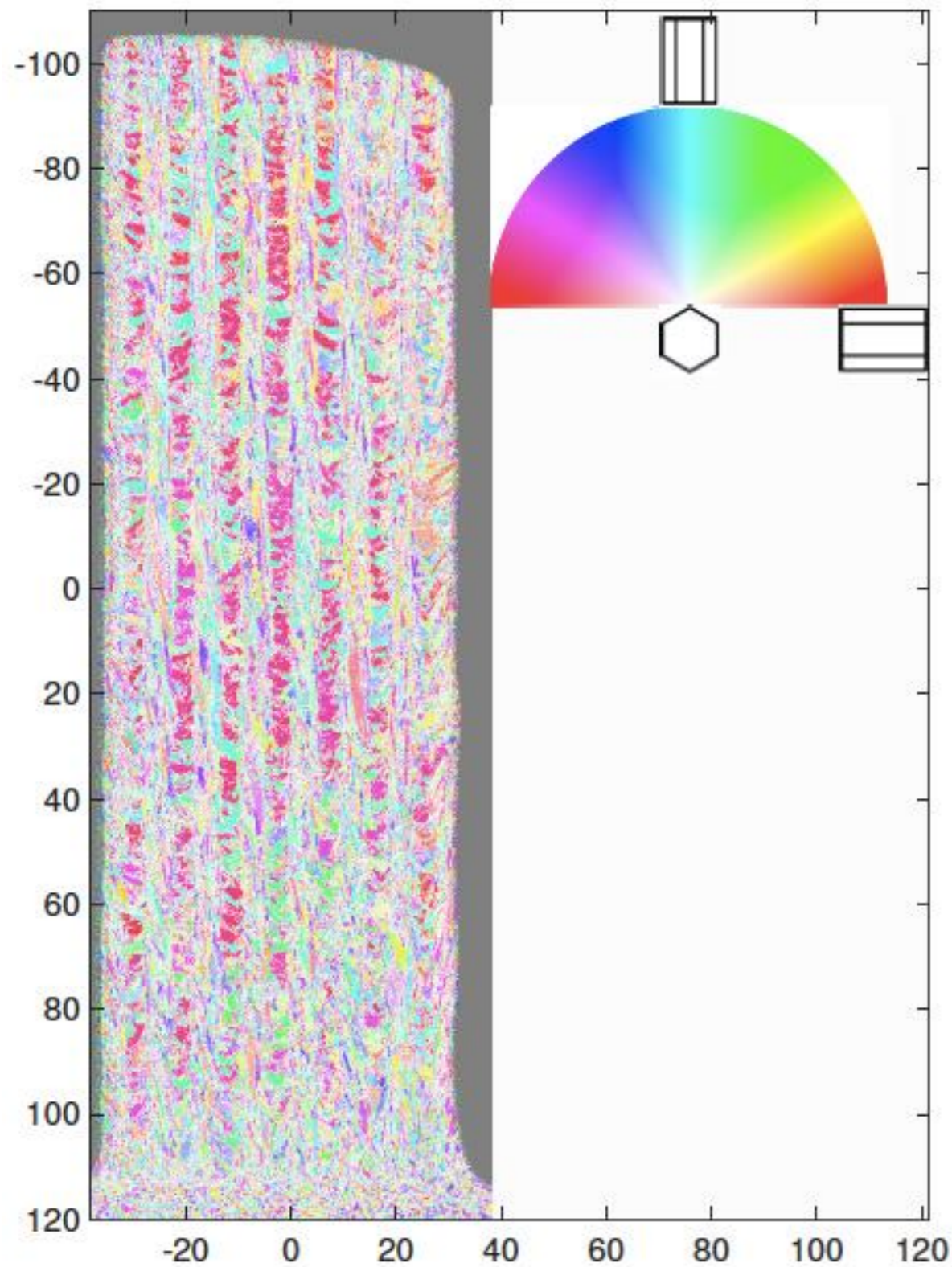
## (3) Orientation imaging - fit to data

$$F(h, k, l, \theta) = \sum_{\phi=0}^{\phi=\frac{n-1}{n}\pi} A(\phi, v_{(h,k,l,(\phi-\theta))}), \quad (n = 1, 2, 3, \dots)$$



- ▶ The merit function is simply the sum of the amplitude under the black asterisks on the graph
- ▶ Repeat this procedure for all the combinations of plane and propagation direction





In these two scans, we may have more orientation data than all EBSD scans of AM Ti-6Al-4V combined.

So, let's make a SRAS system...

...but let's integrate it into a serial sectioning  
tool

(as if SRAS is not hard enough)



With credit given to:  
The Art of Electronics (Horowitz & Hill)

Robot 2

Optical  
Microscope

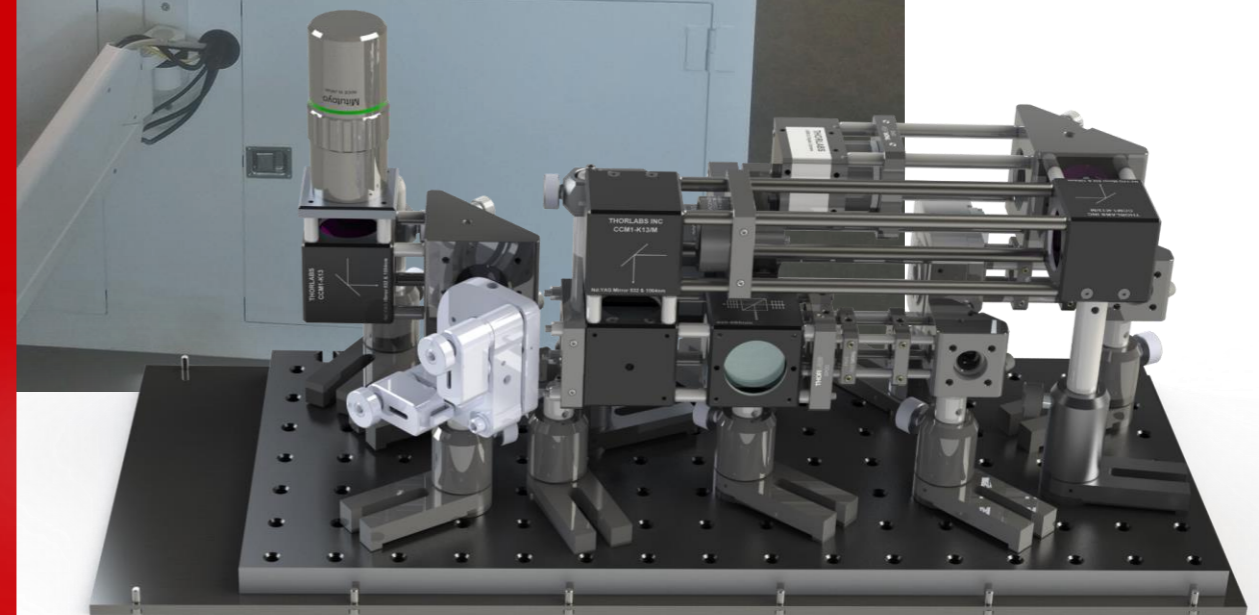
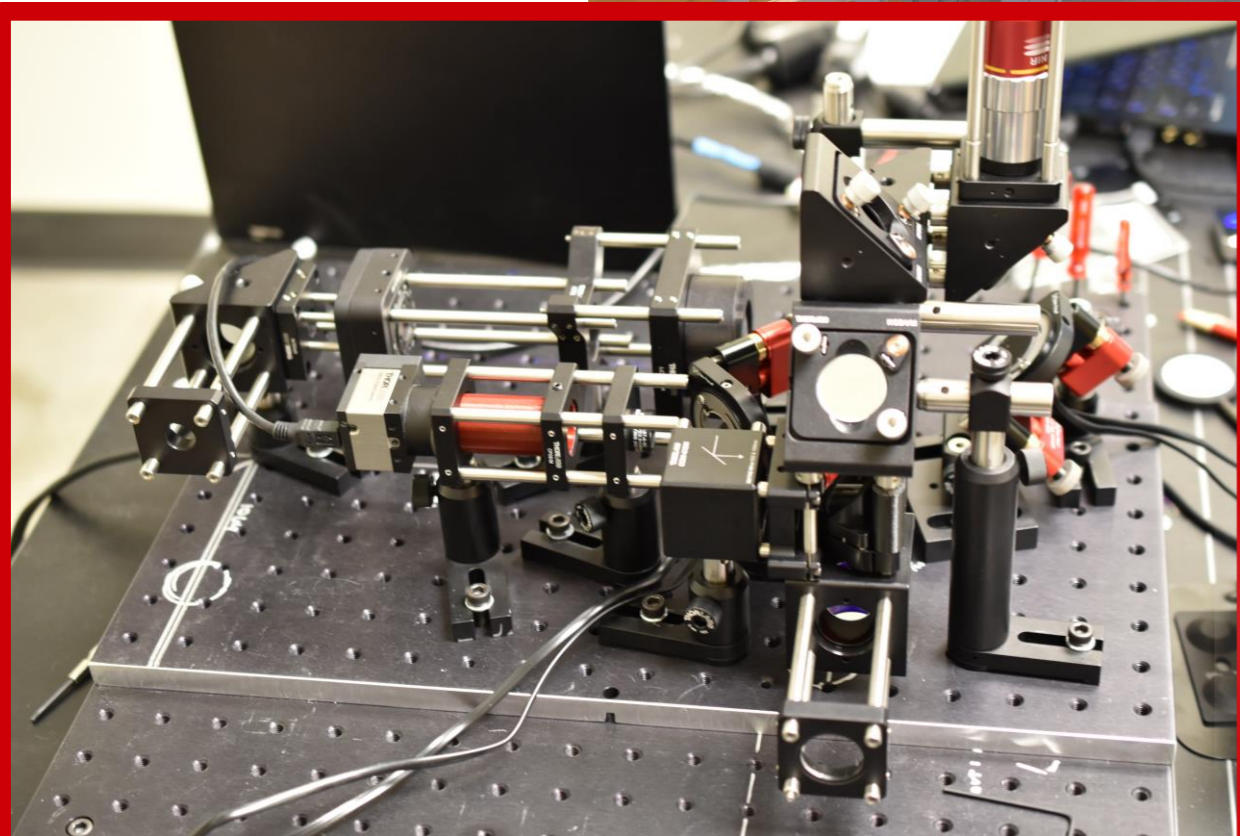
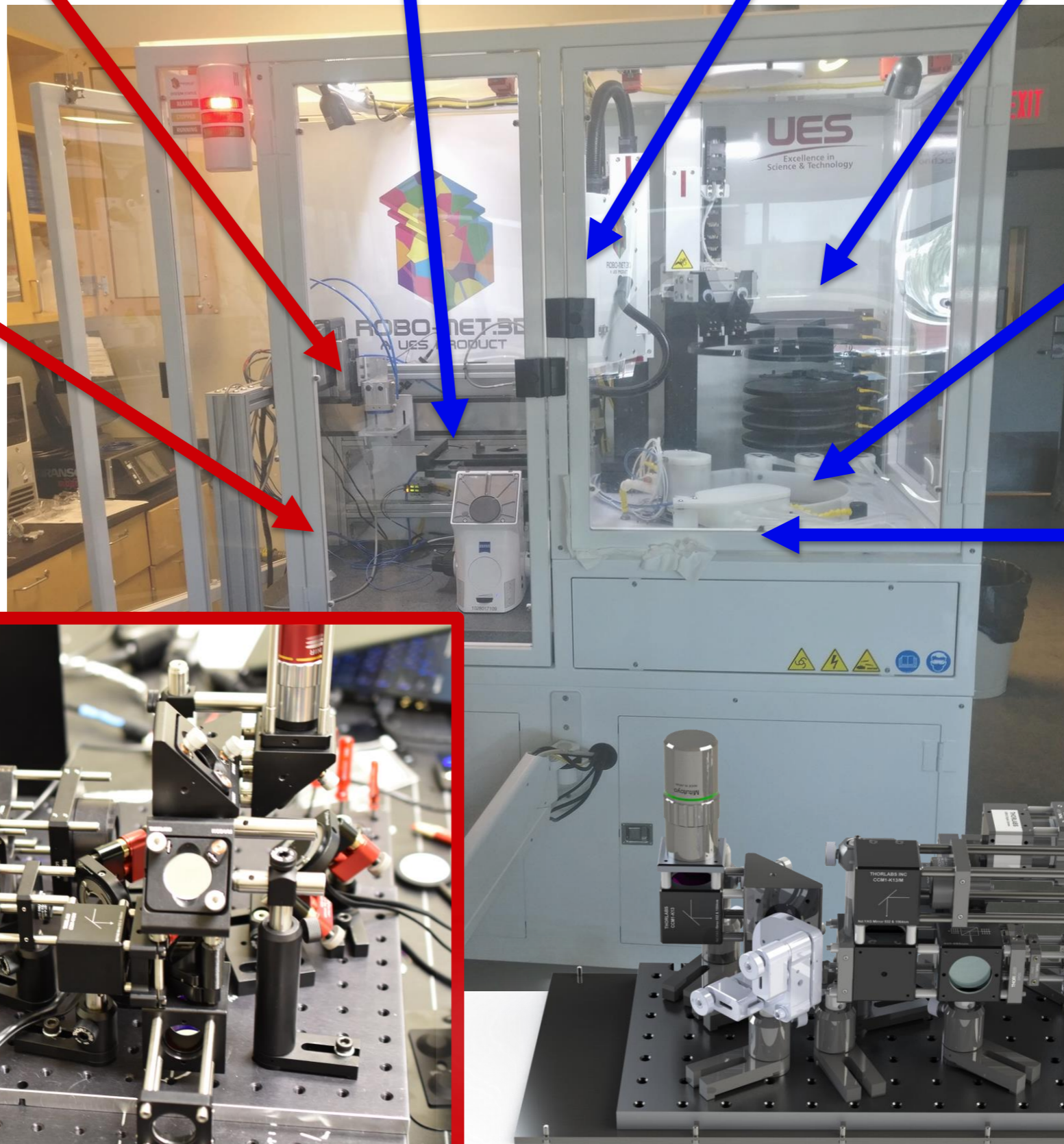
Robot 1

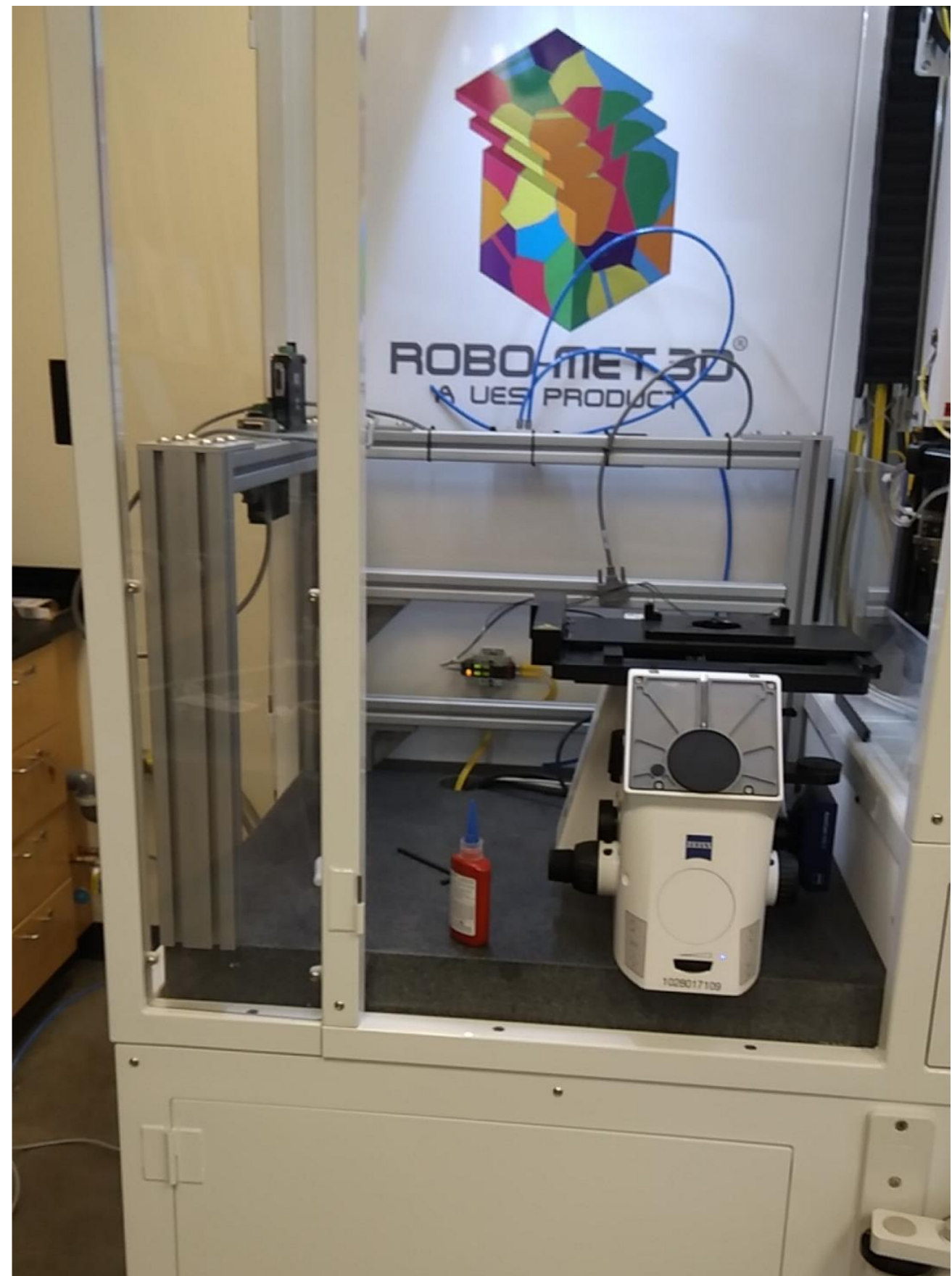
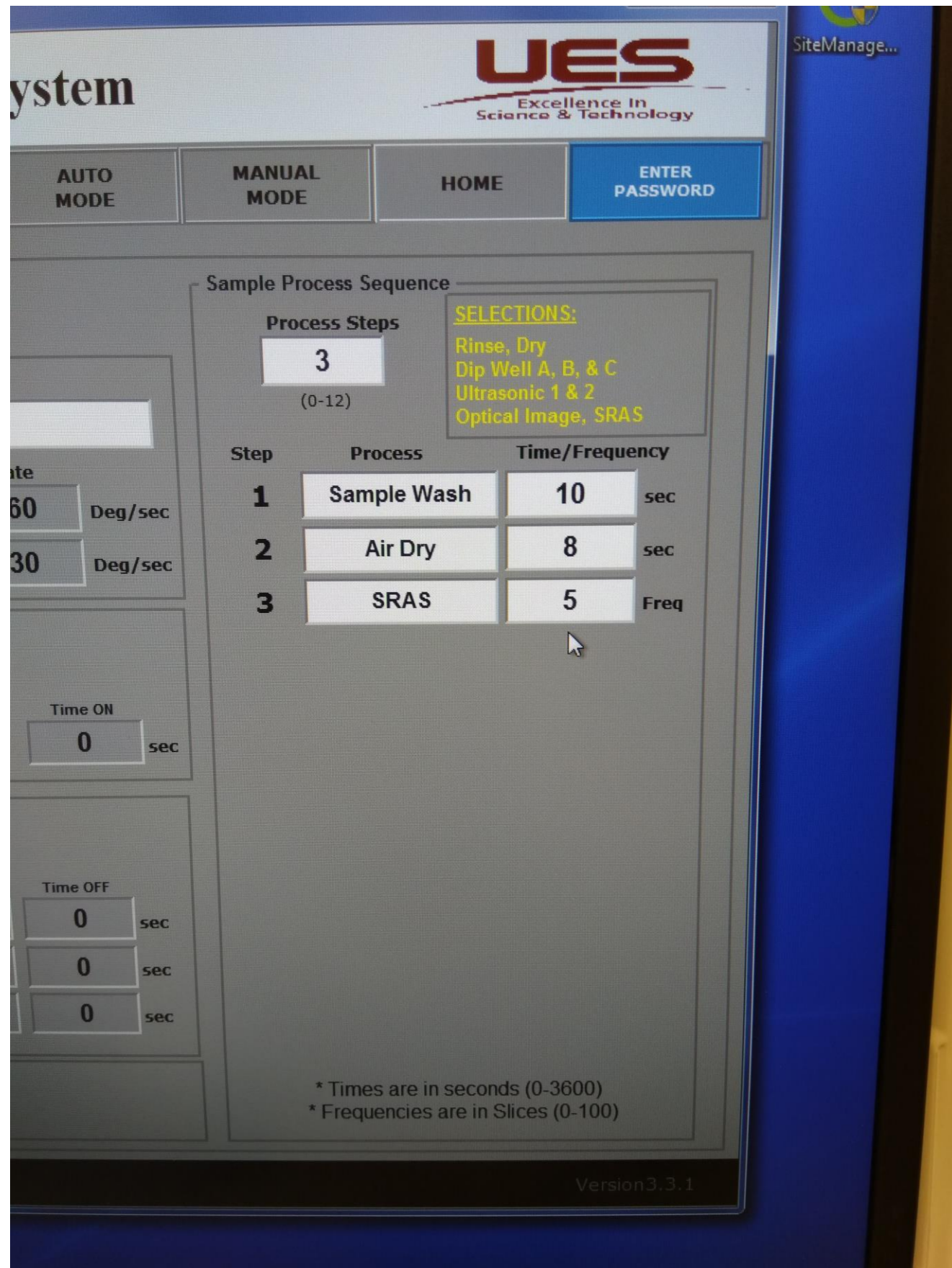
Auto Platten  
Changer

SRAS

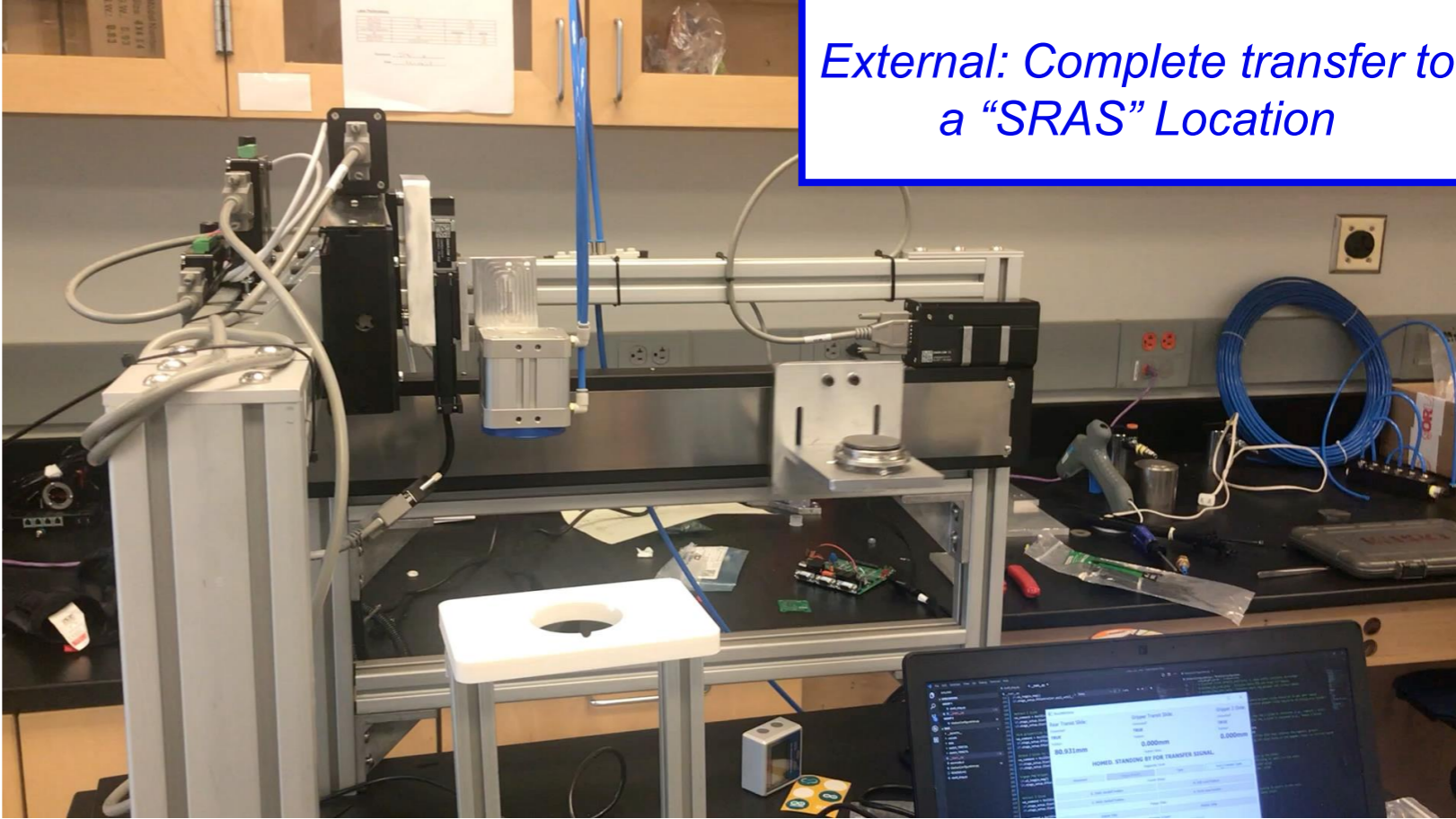
Polishing  
Wheel

Etching  
Station

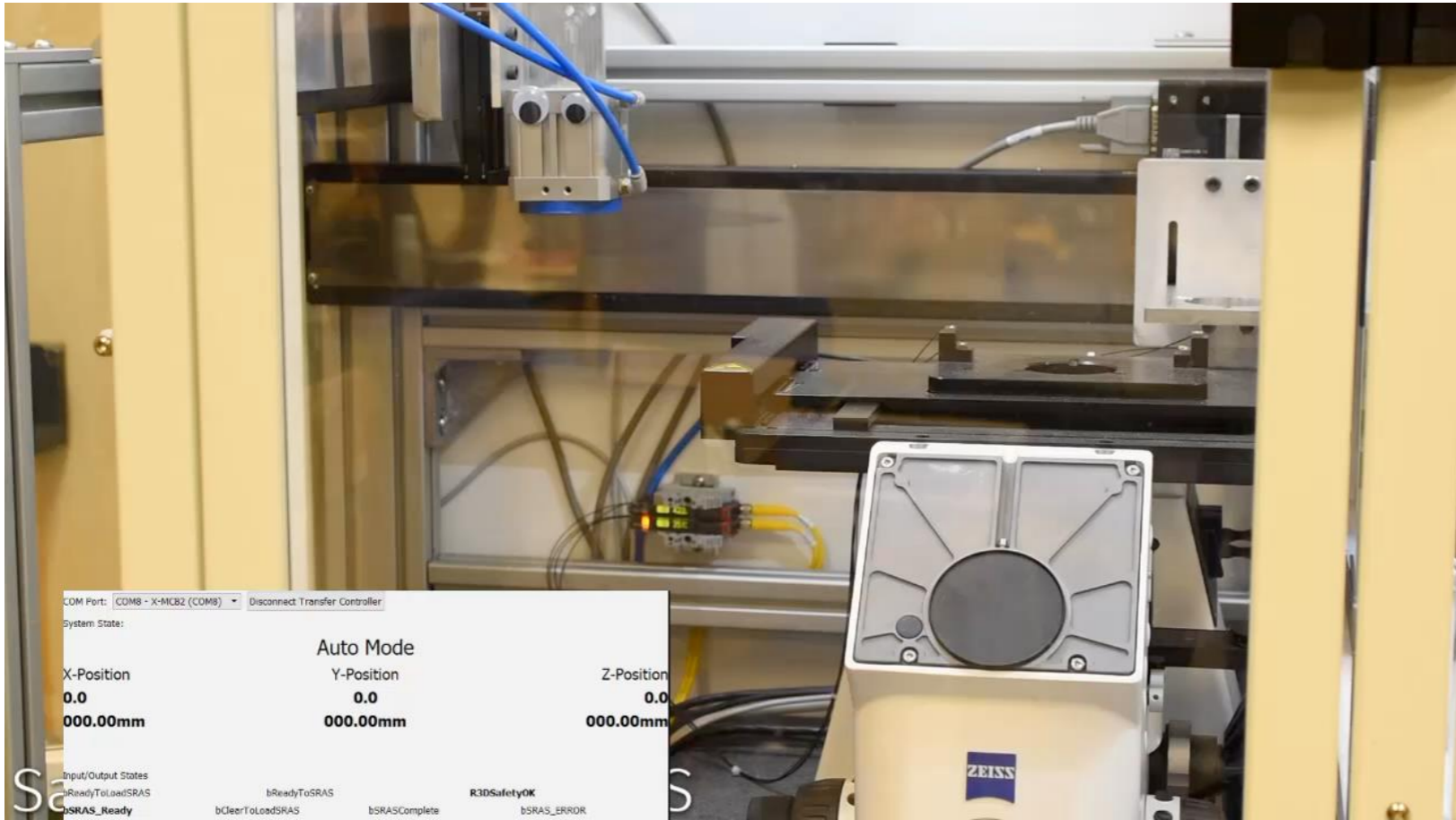




# Automated robot transfer system



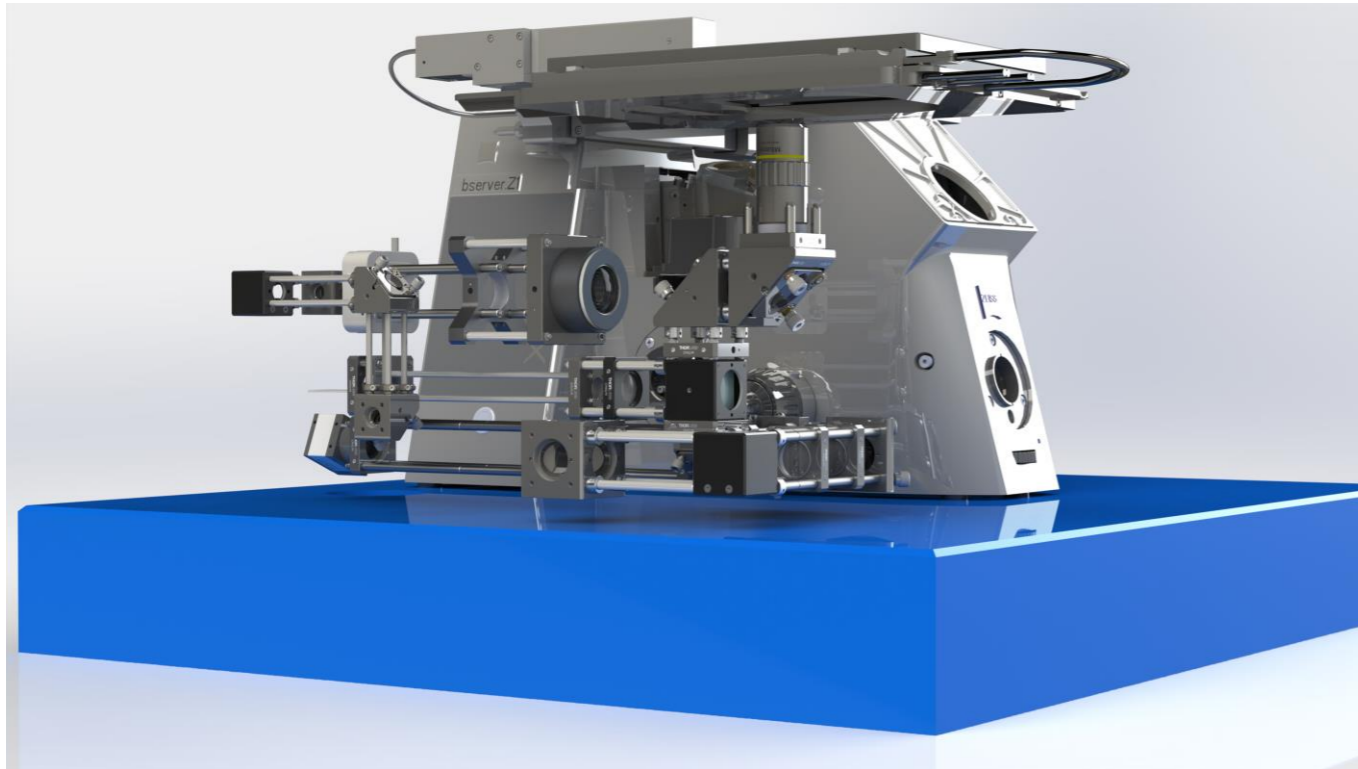
*Below: Internal (no drop-off) with code. Precision of location.*



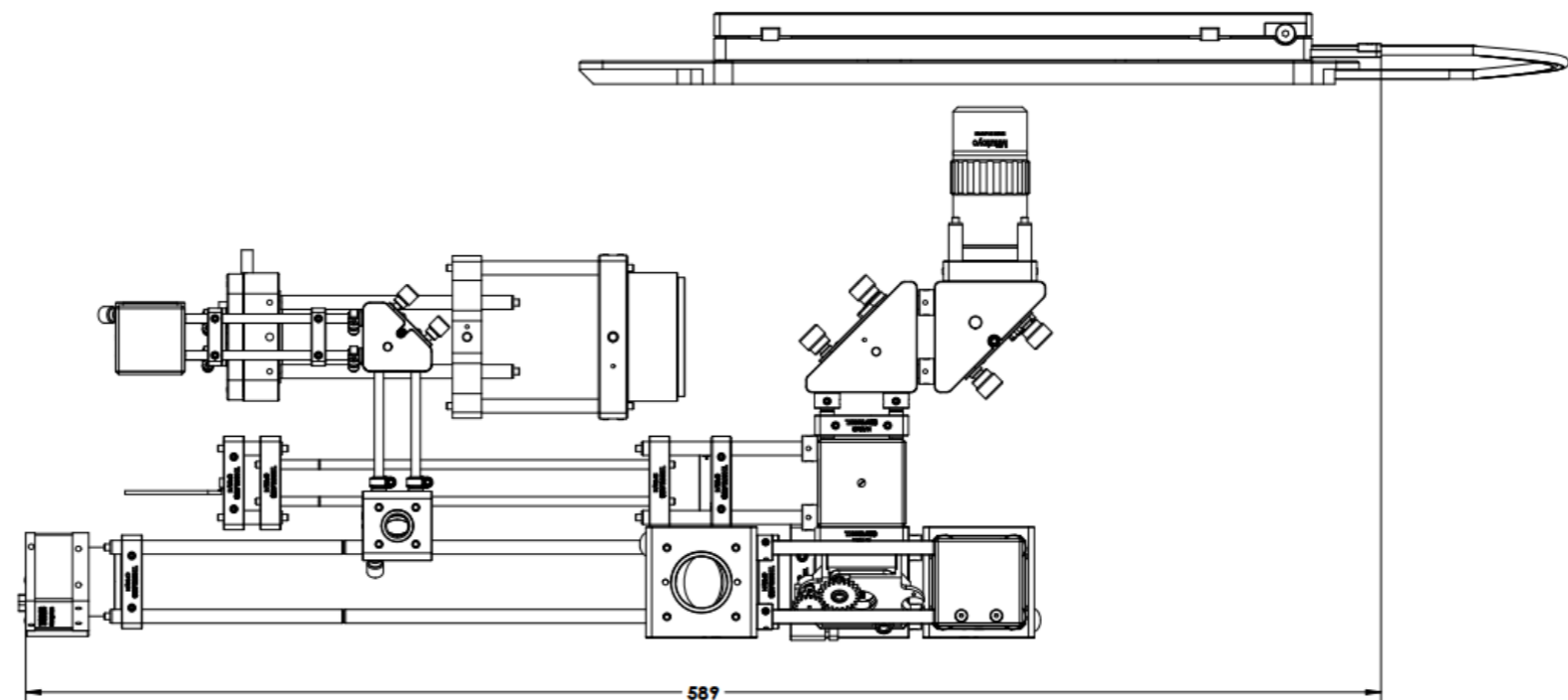
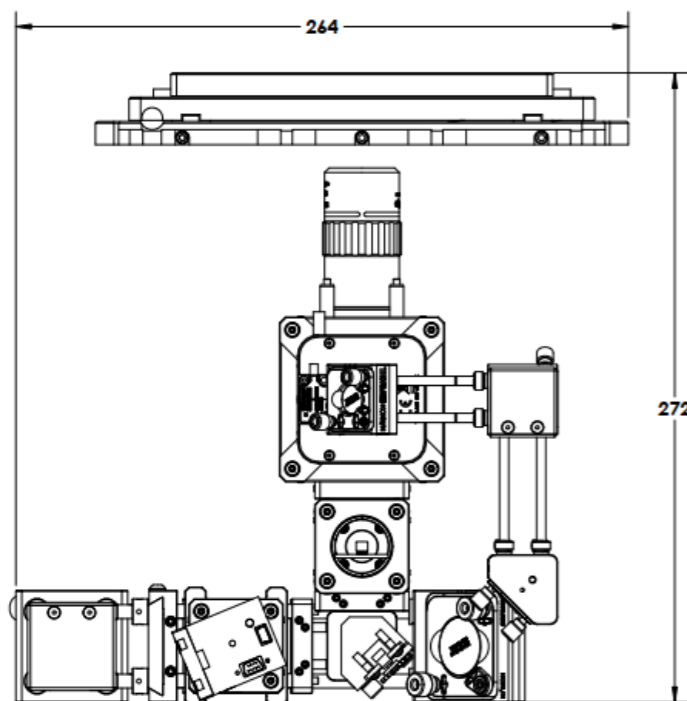
**Possibility: Expansion for other "drop off" sites. Ultrasound? X-Ray? SEM?**



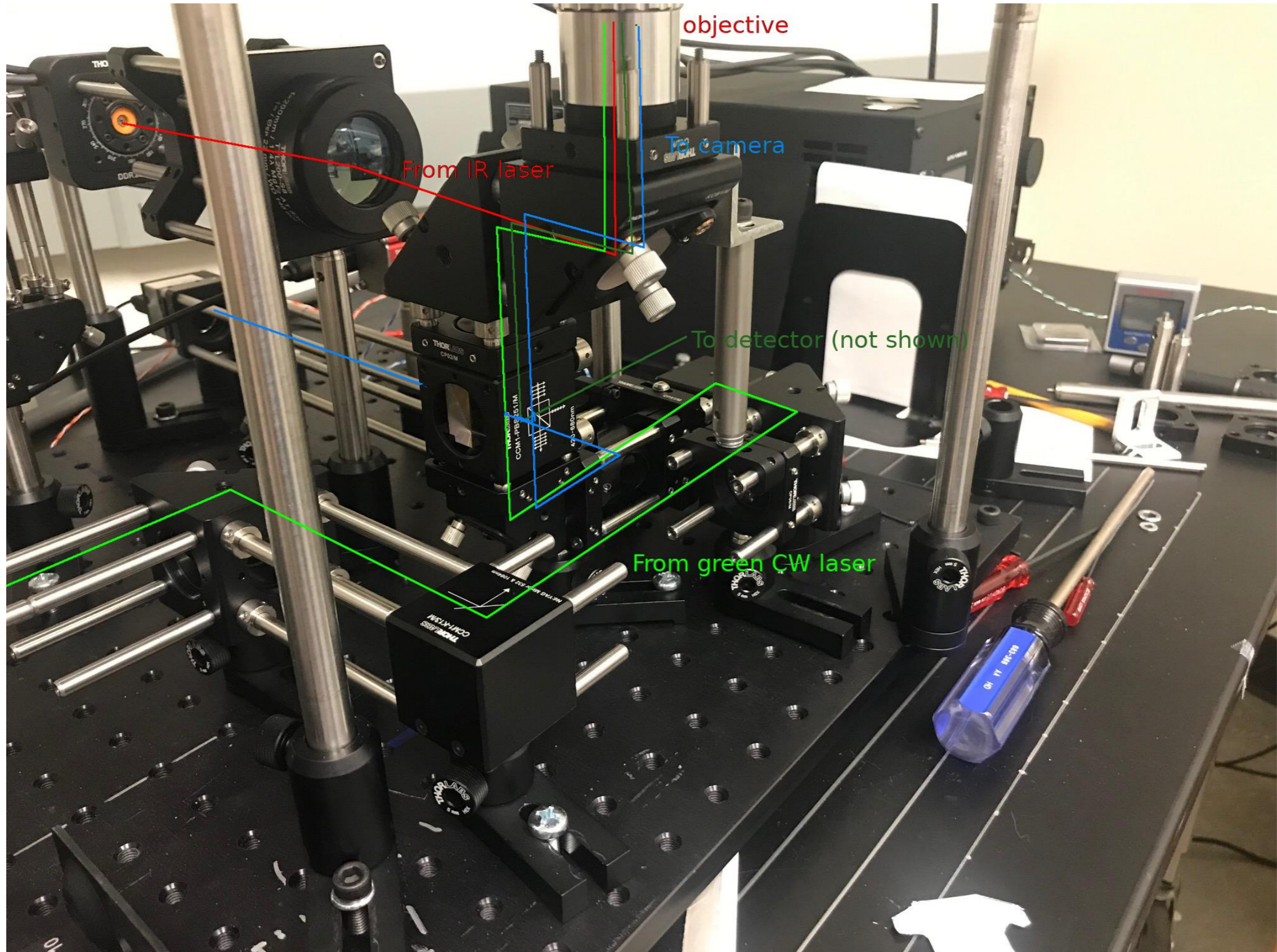
# Engineering a new system

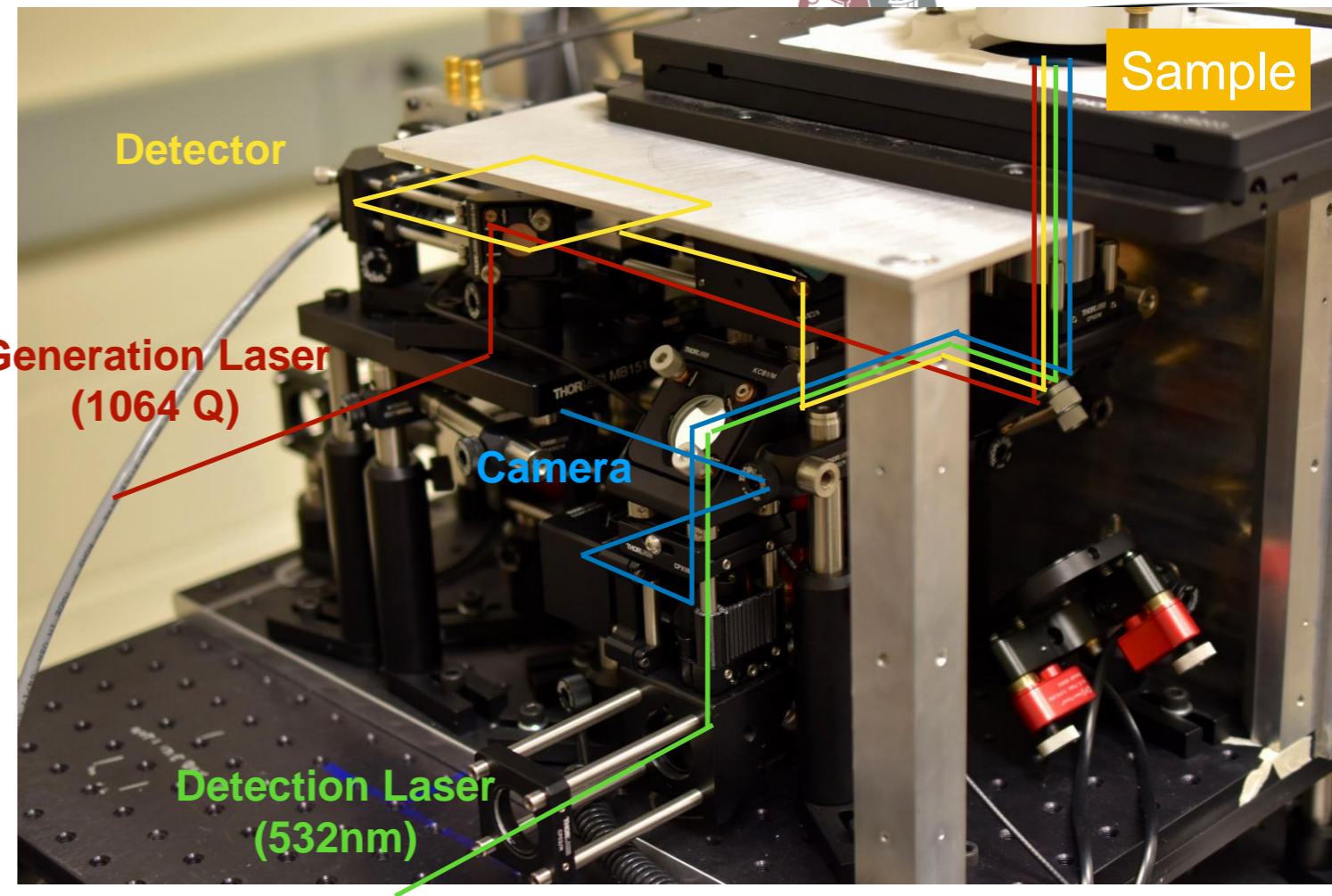
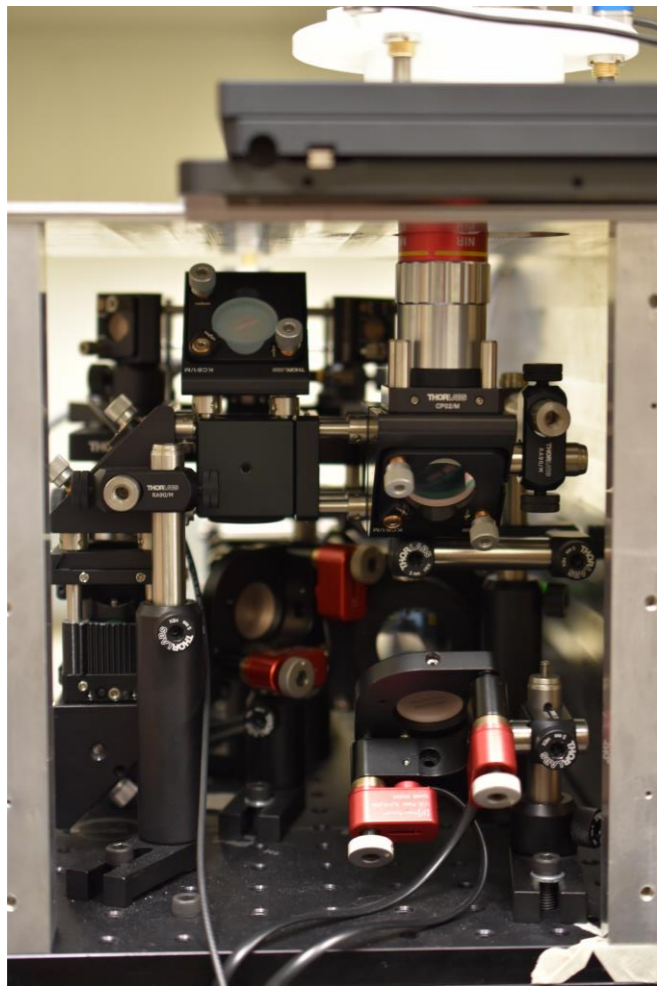


- Must wrap a 2D system to a 3D package
- Highly space limited
- Safety!
- Detector components no longer exist
- Bandwidth (150-500 MB/s if we collected everything!)
- Thus, we need triggers
- Saves on data (makes TBs datasets GB instead - RAW)
- A true engineering challenge!!



# First Original 3D Beam Path



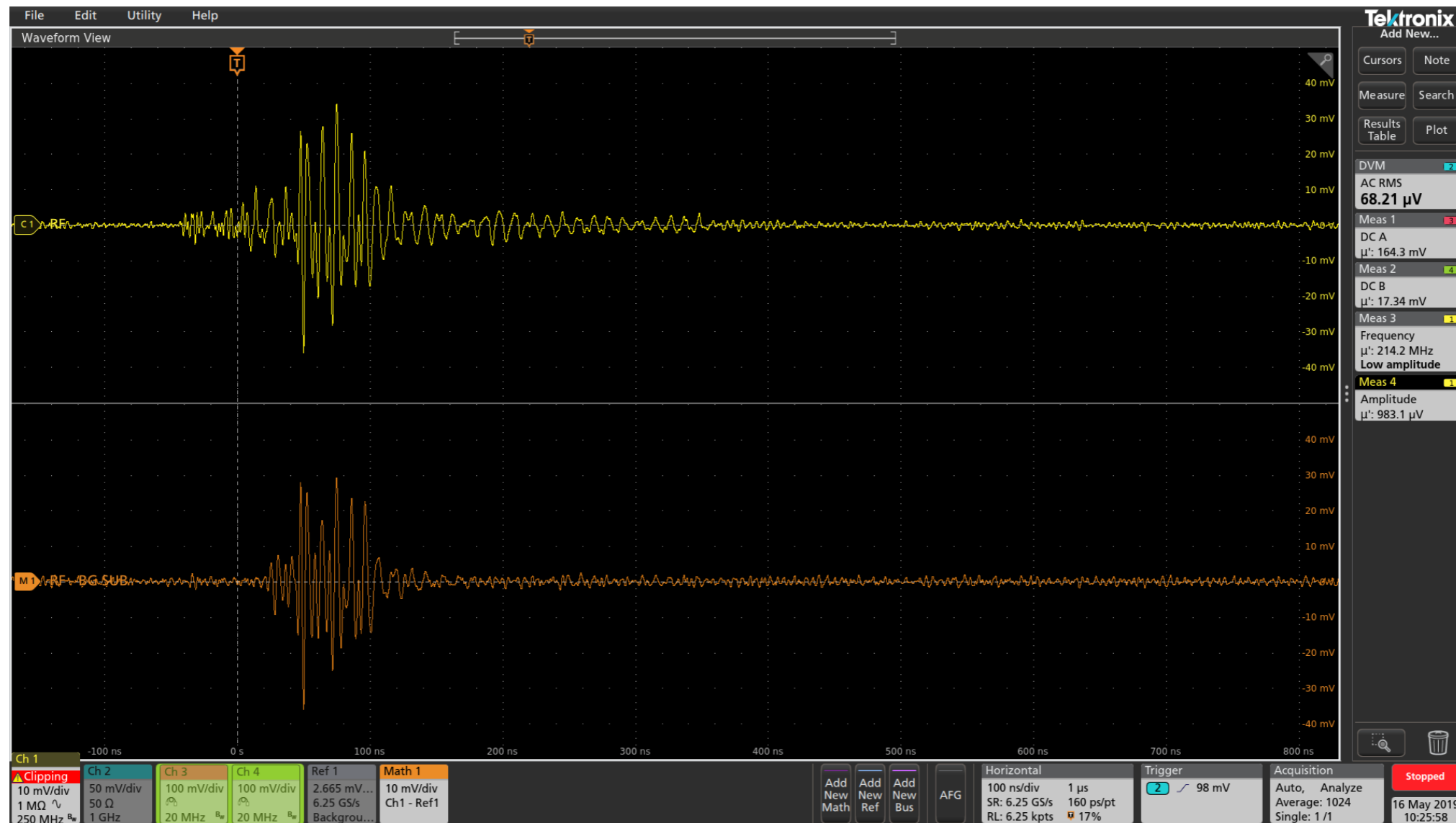


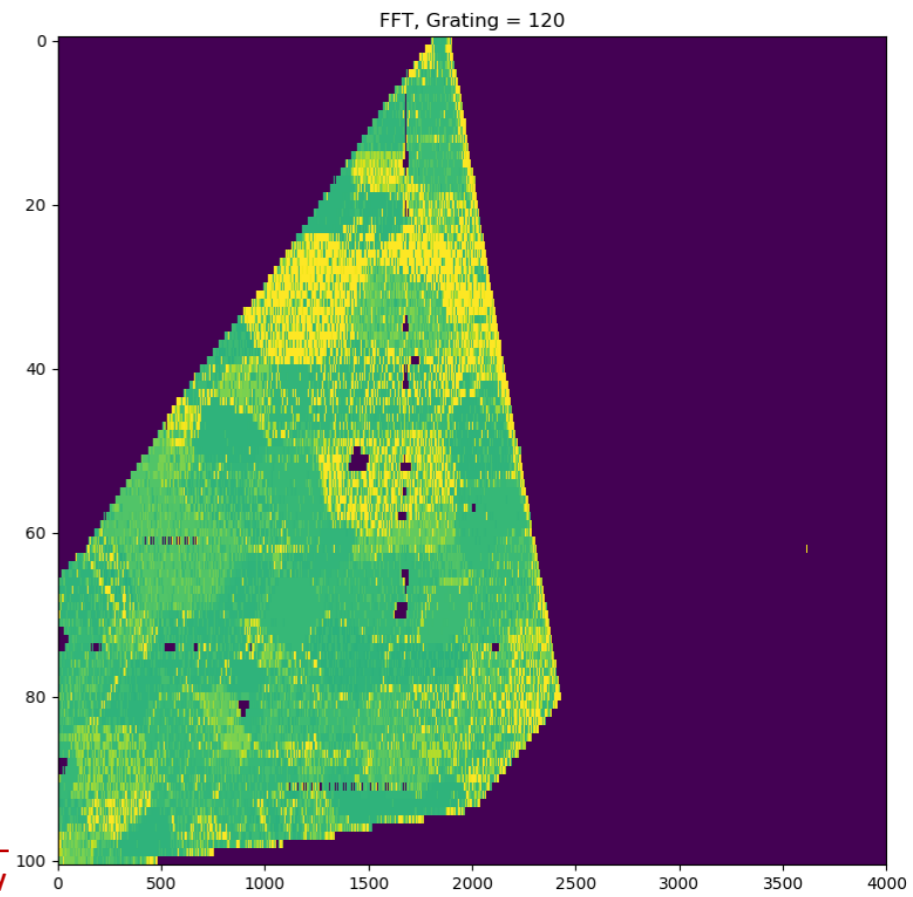
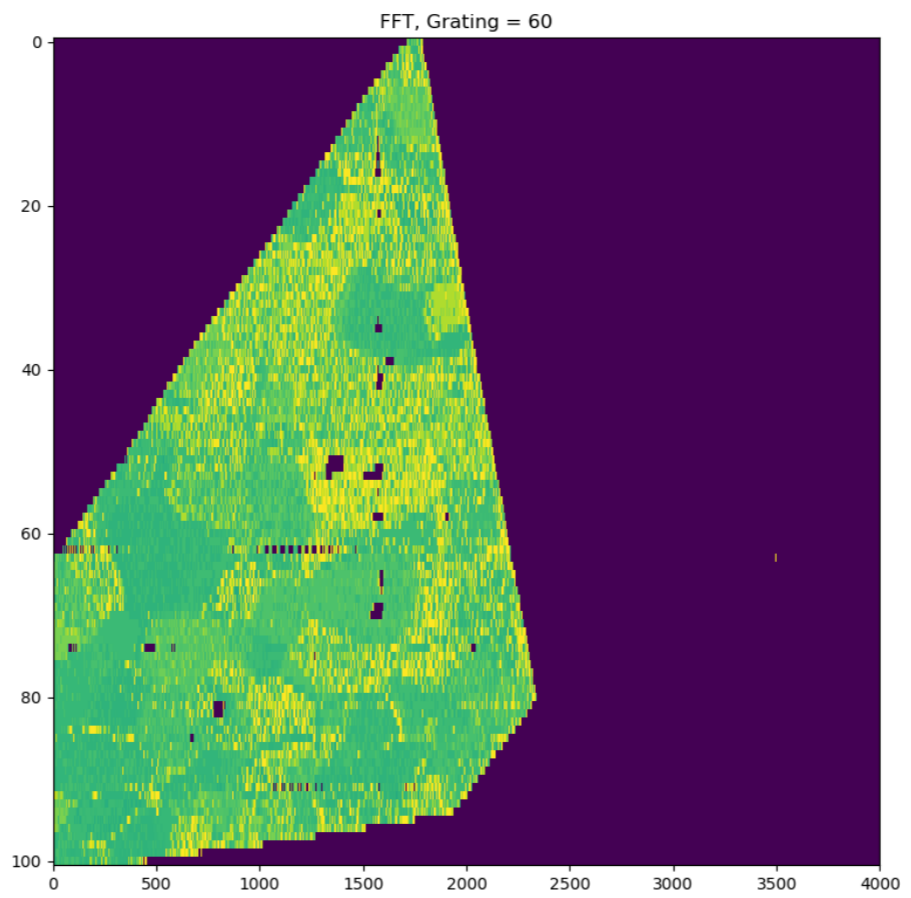
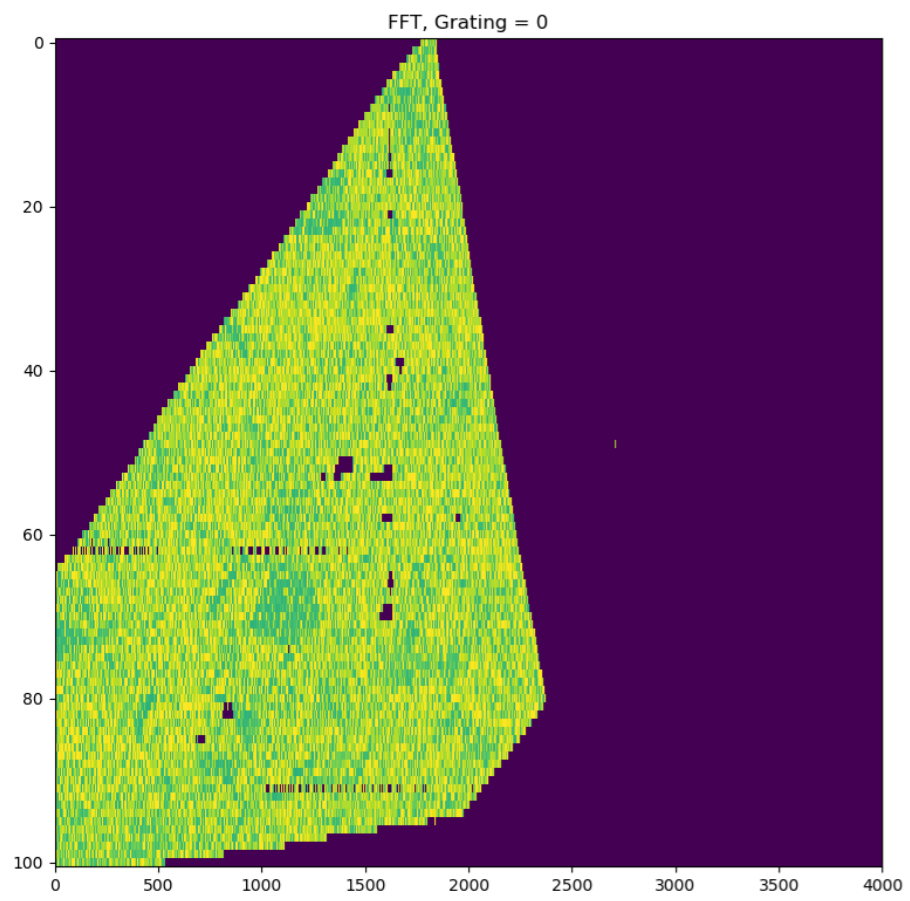
Subsystem		
<b>Generation Laser</b>	Type	Q-switched
	Wavelength	1064 nm
	Pulse Energy	>50 uJ
	Pulse Duration	<900 fs
	Frequency	200-100 kHz
<b>Detection Laser</b>	Type	Continuous
	Wavelength	532 nm
	Mode	TEM00
	Power	0-500 mW ~200 mW

Subsystem		
<b>Stage</b>	Speed	250 mm/s
	Acceleration	2500 mm <sup>2</sup> /s
	Backlash	None
	Accuracy	<0.25 um
	Incremental Movement	<100 nm
<b>Detector</b>	Type	Balanced Split PD
	Generation	New (1st since ~2011)
	Frequency	< 500 MHz
	Spatial Resolution	~ 25 um

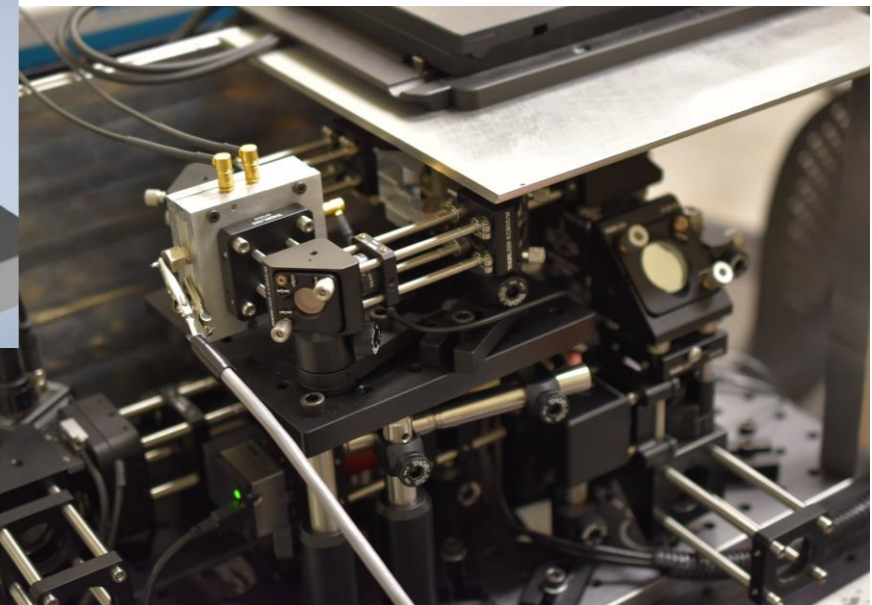
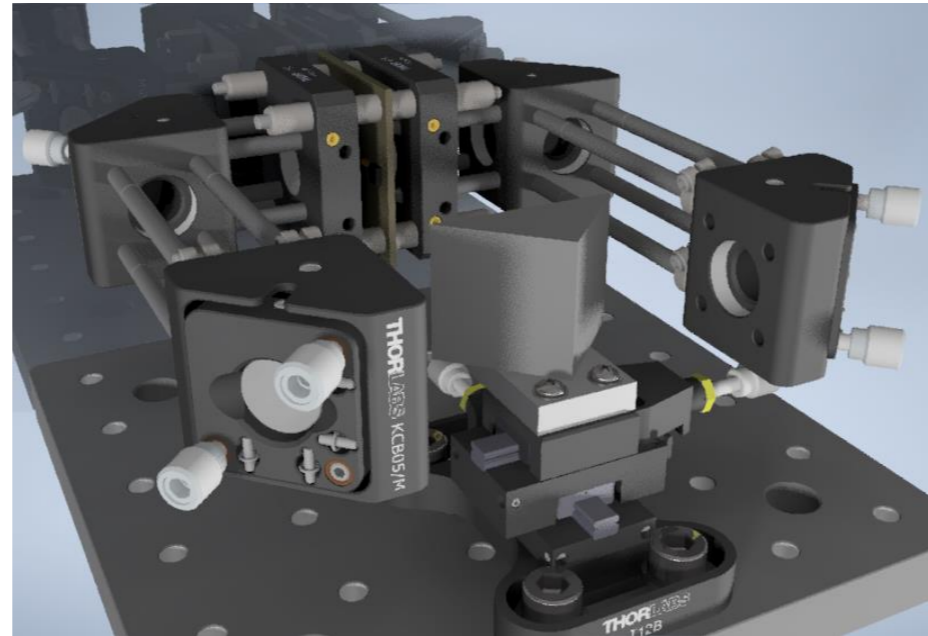
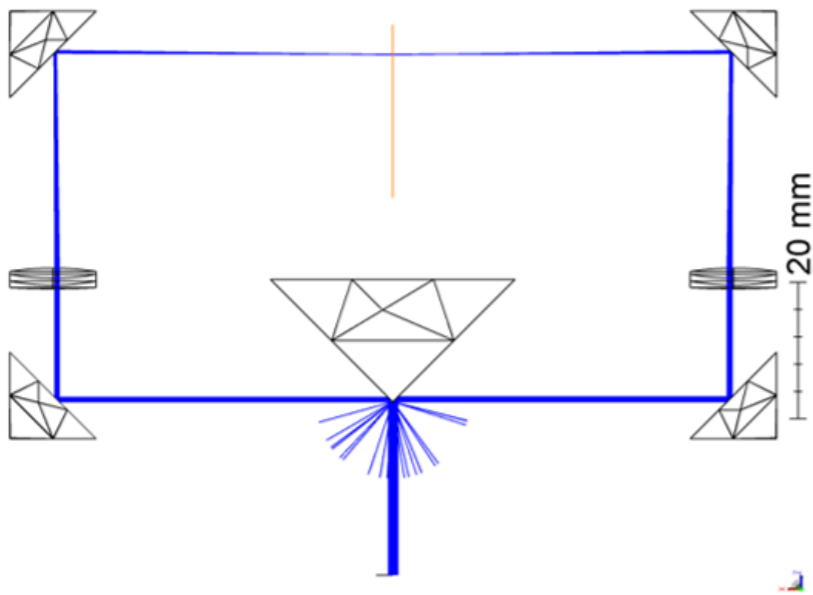
# Detector (Nottingham "Slow")

## First signals (June)

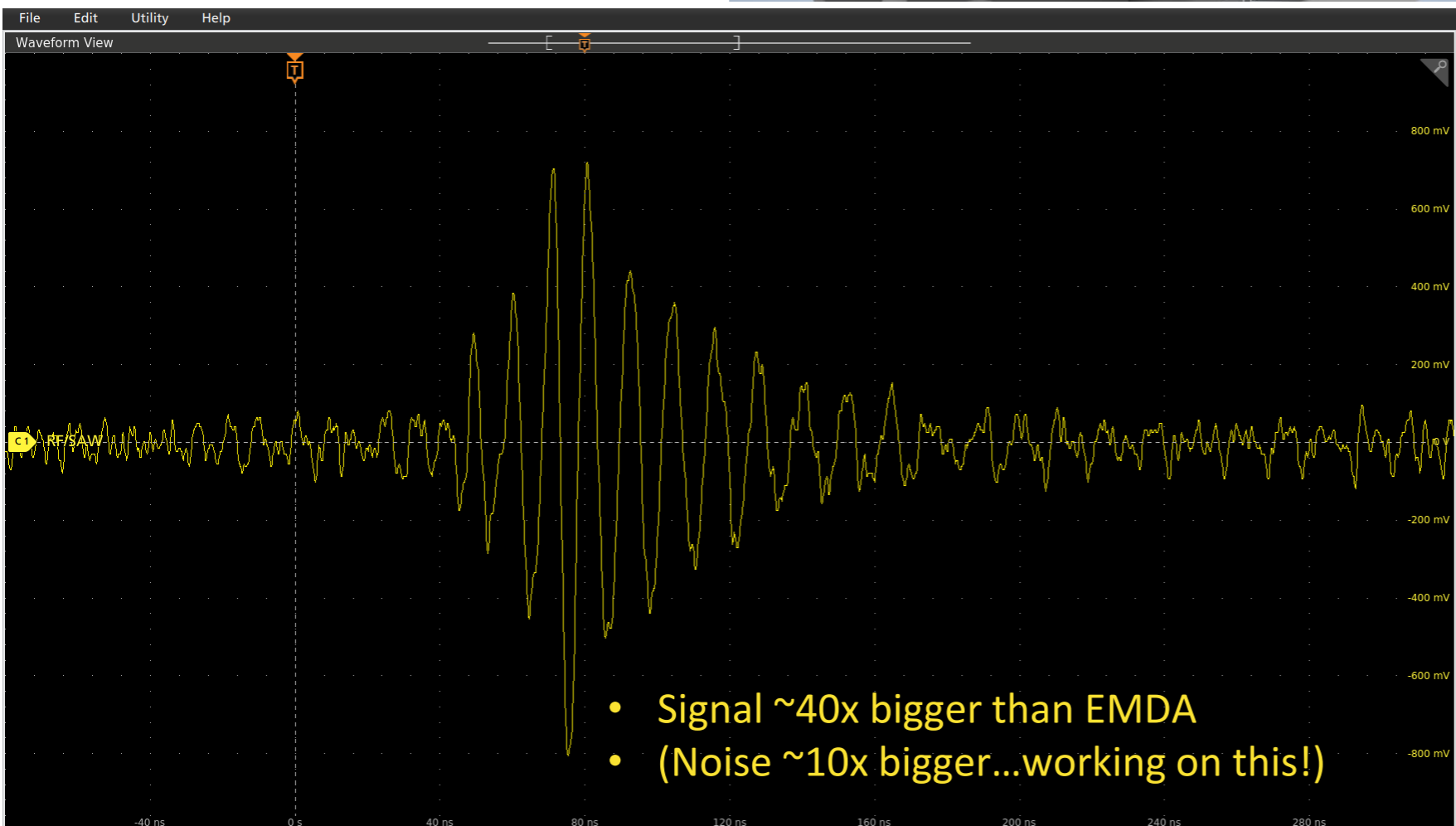




# Detector (Gen 2 - new design)

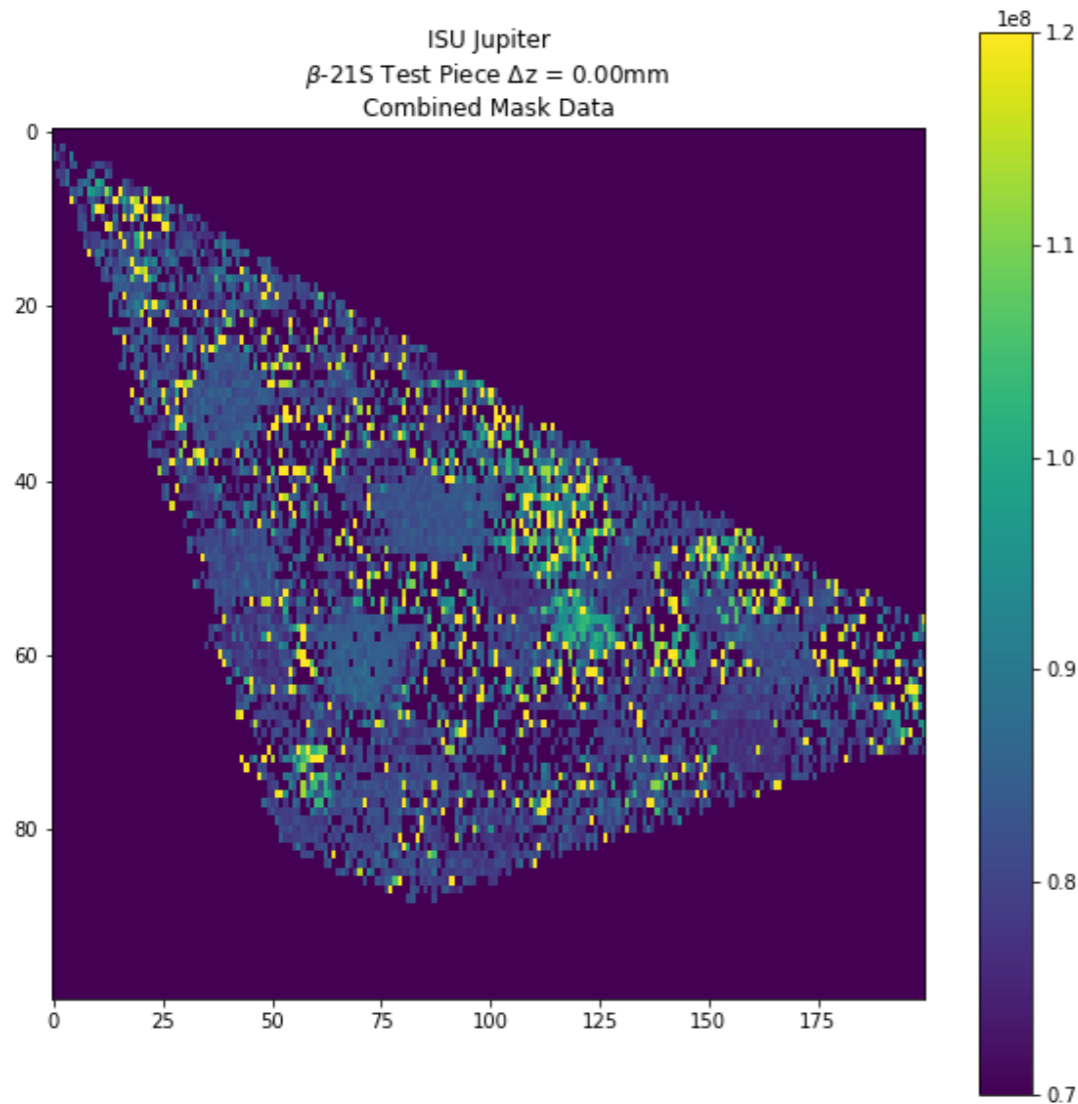


**November**

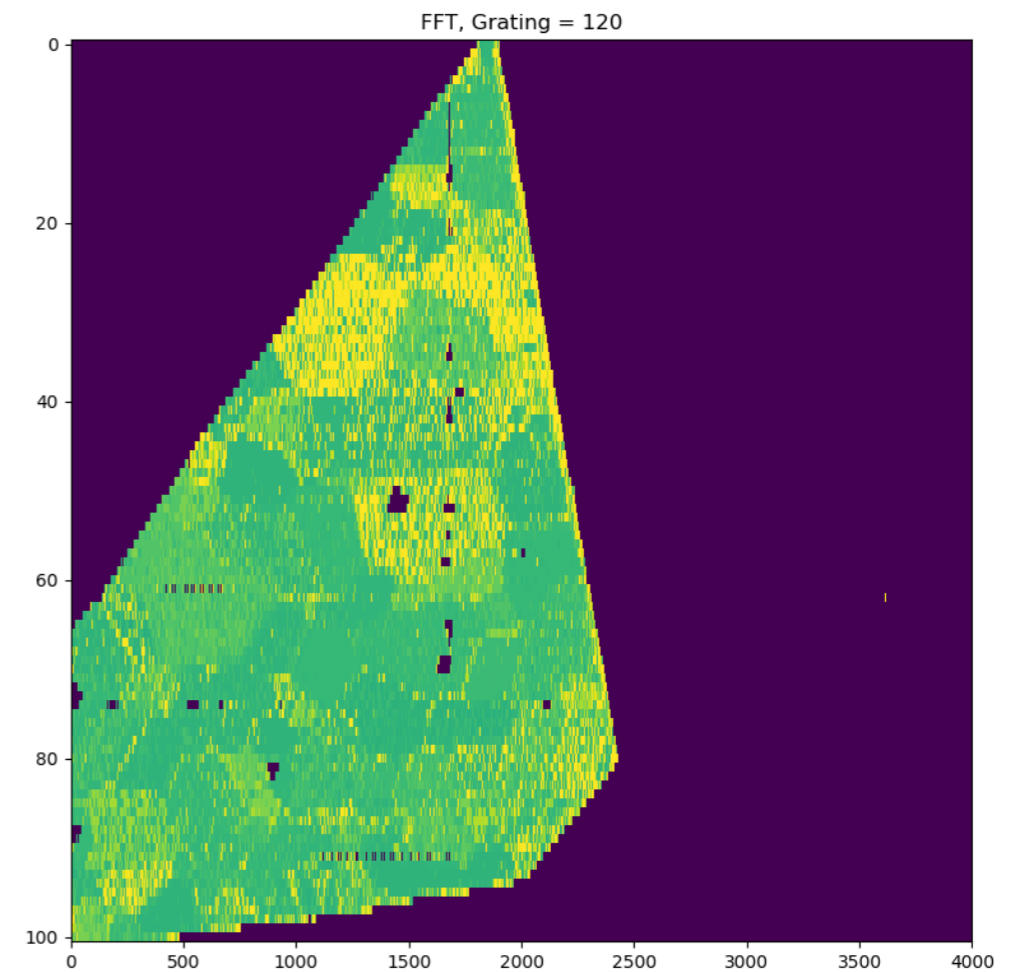


# Present State-of-the-Art

- ISU Alpha system running, efforts being spent on improving resolution, data acquisition and data transfer rates
- Current RAW data is  $\sim 15 \text{ MB/mm}^2$
- Potential to move away from oscilloscope storage for data



1<sup>st</sup> scan acquired

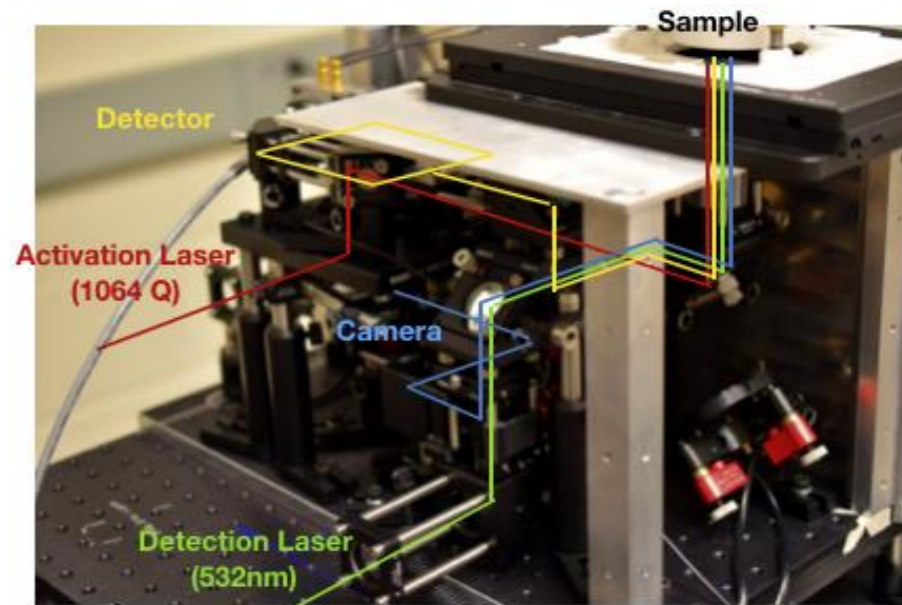


latest scan

# What is left...in the short term

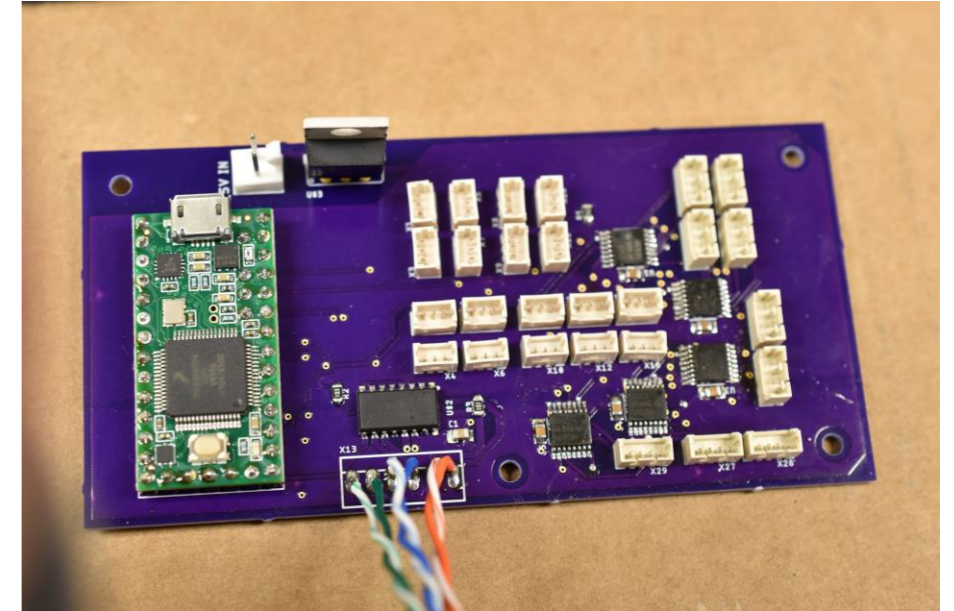
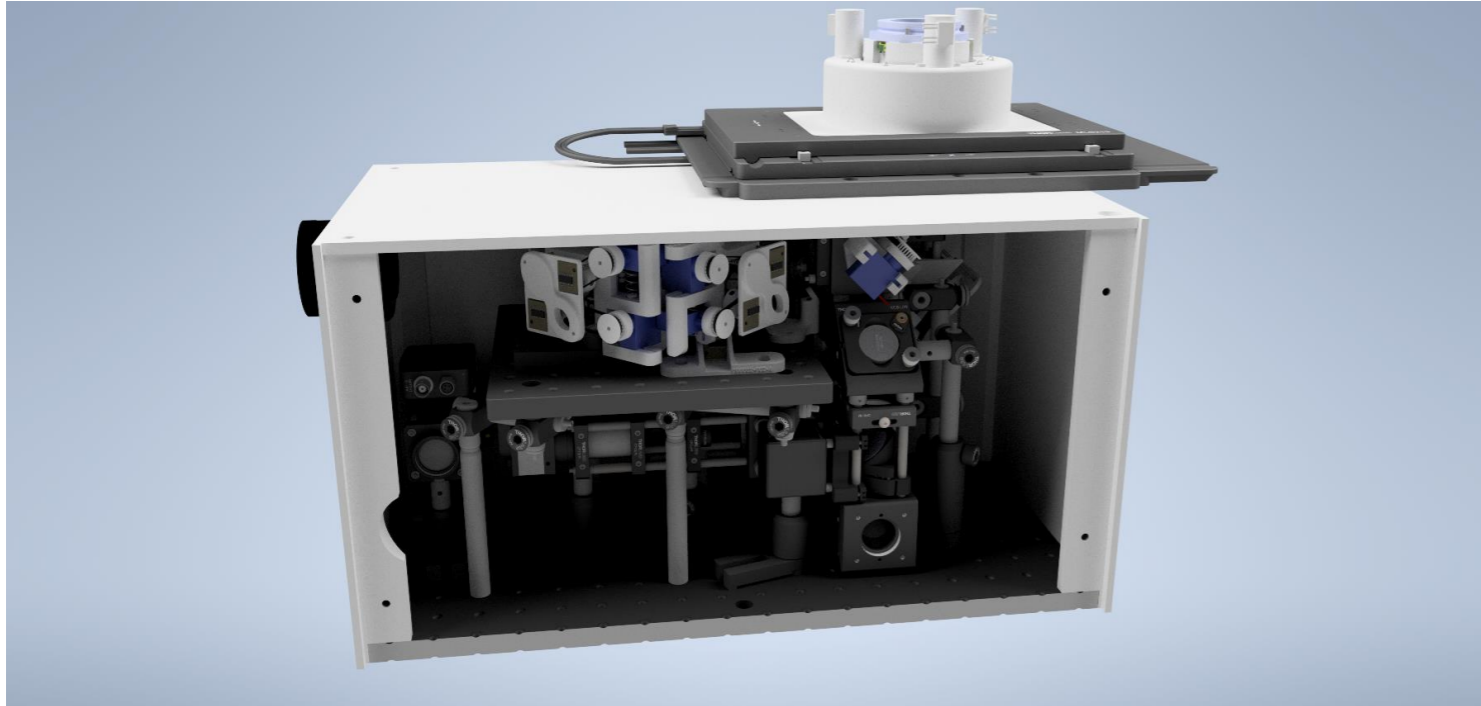
Left to resolve:

1. Taking hands out of the system
  - Requires motorizing mirrors (alignments for every rotation ... at the moment) - very difficult to do in an already very tight shoe box
  - Requires digital cameras for alignment
2. Make the system “Class 1” laser safe
3. Transition to fiber coupled lasers
4. (intermediate term) - moving from an oscilloscope to direct collection



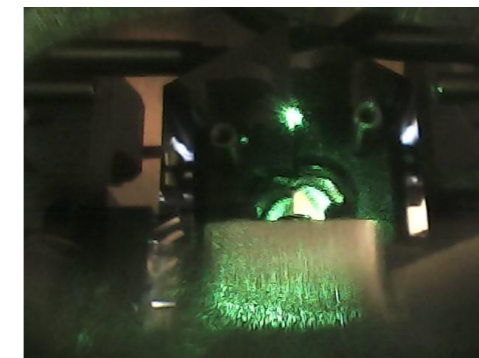
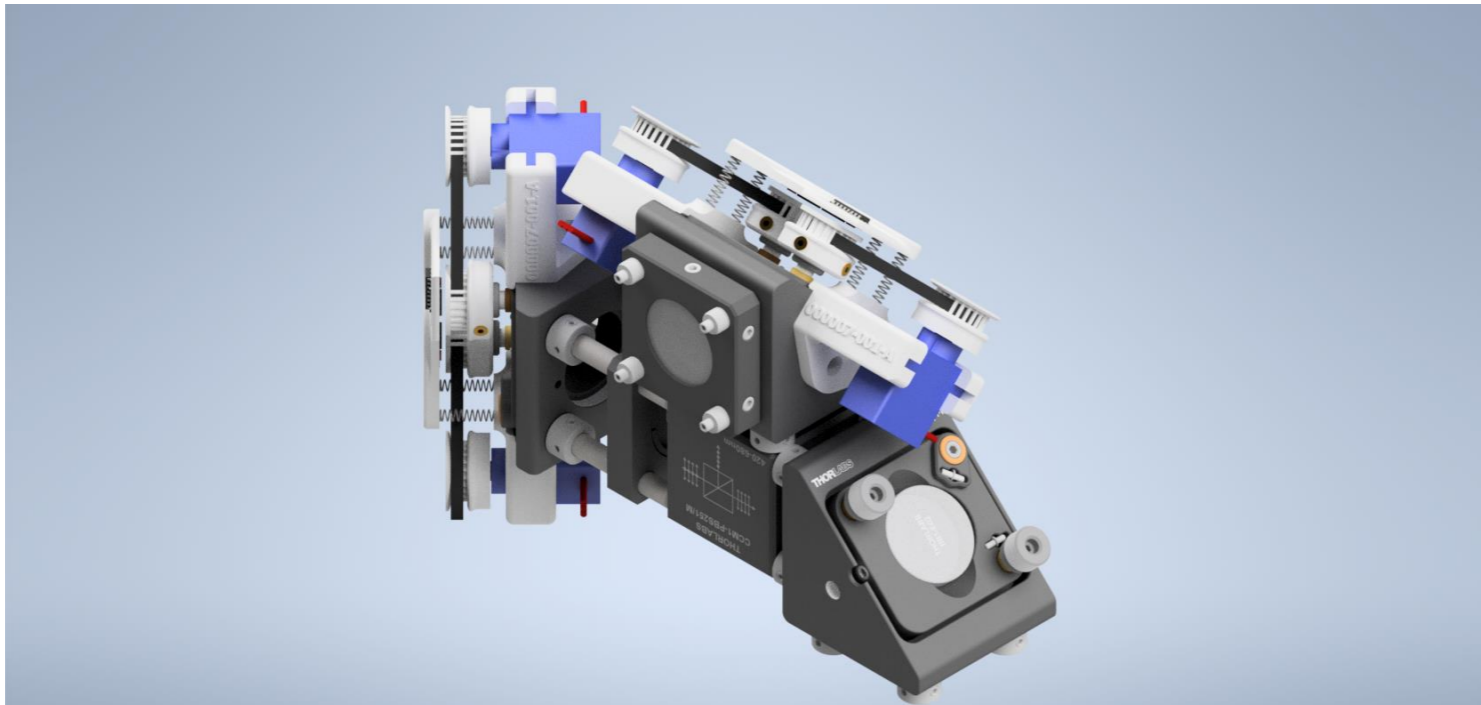


# Remotely Operable

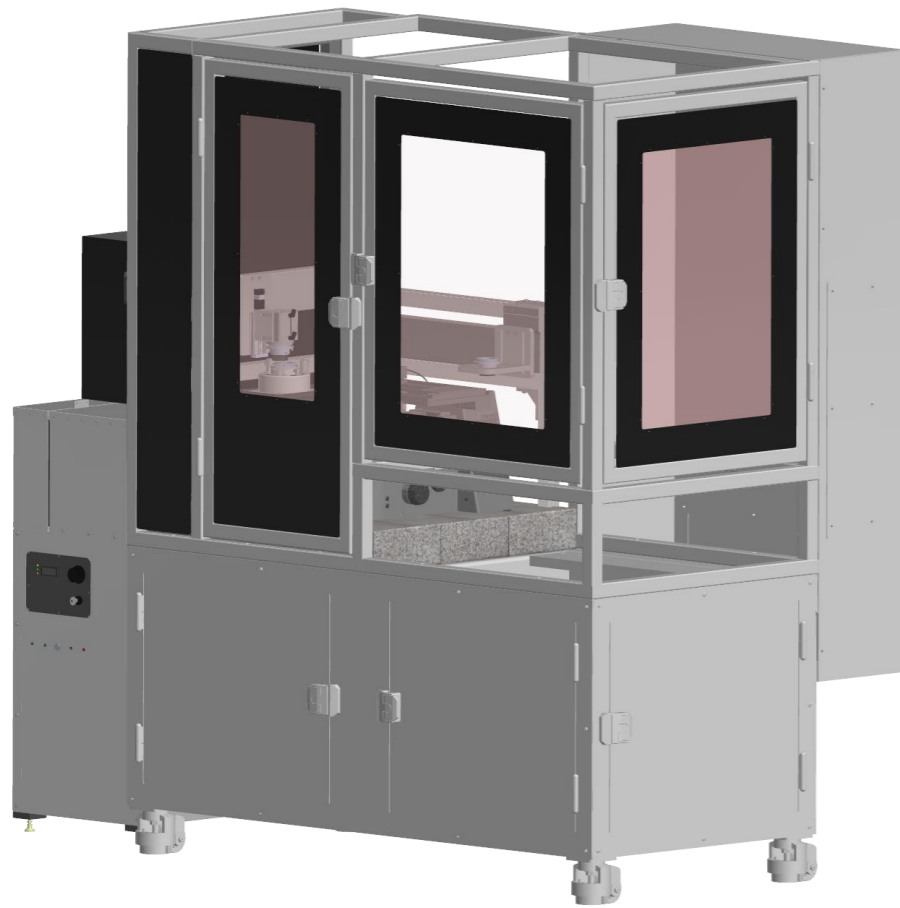


**New motors, drivers, and sensors.**

**Can't be piezo-based.  
Too noisy (electrically)  
Too big**



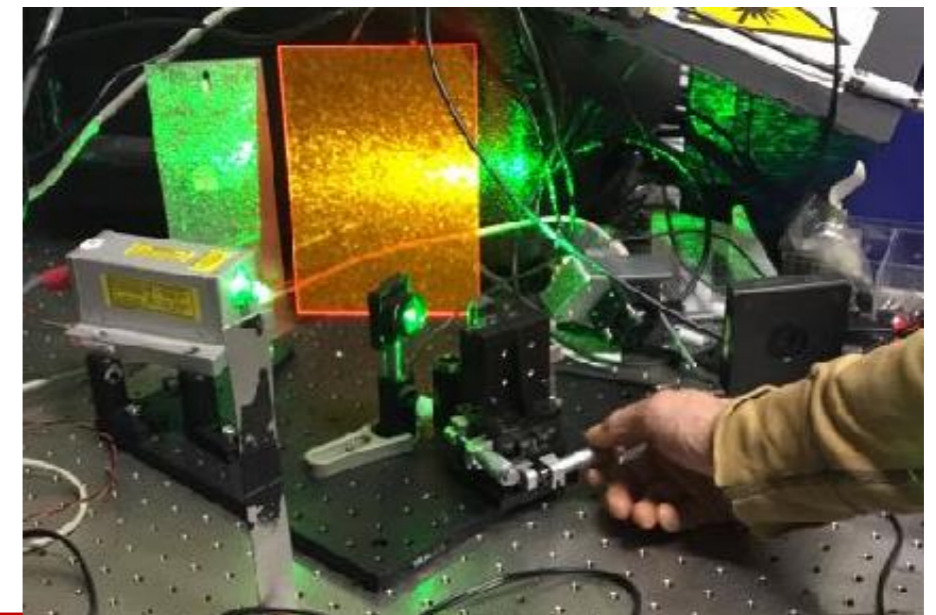
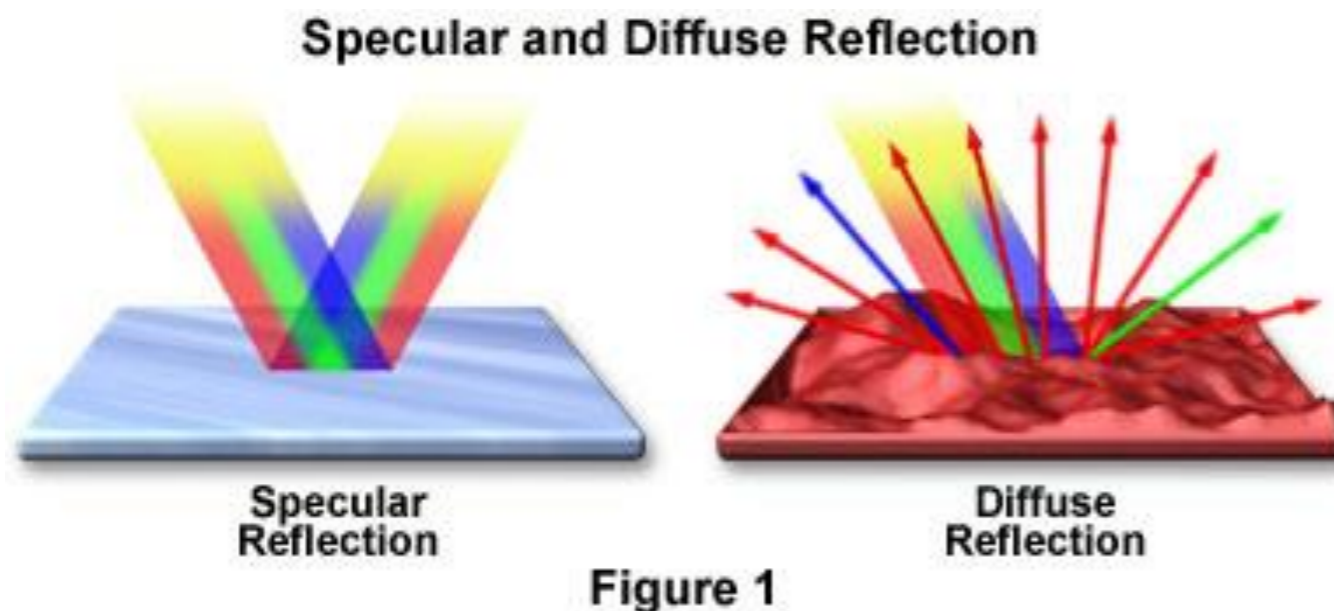
# “Class 1”

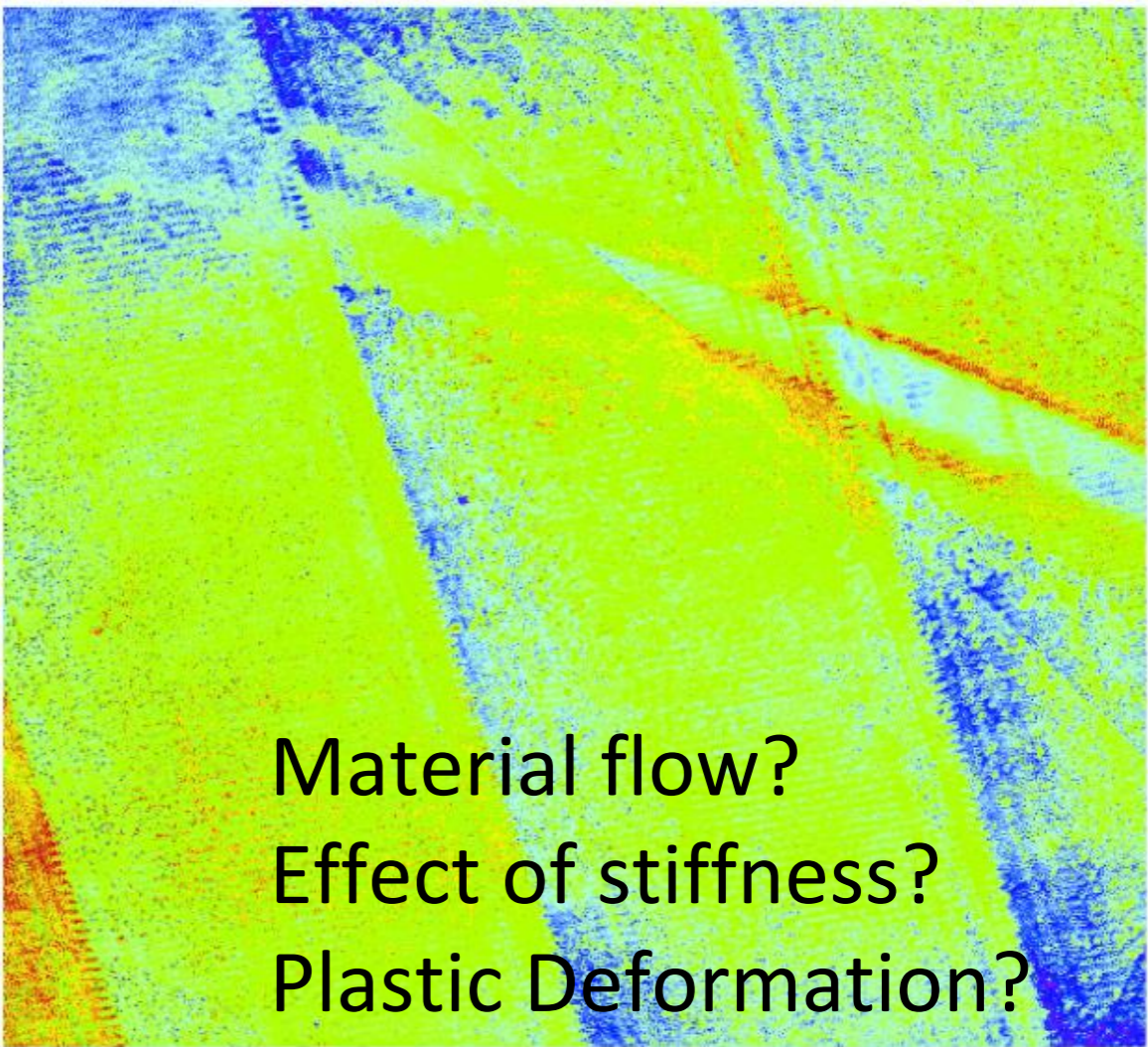
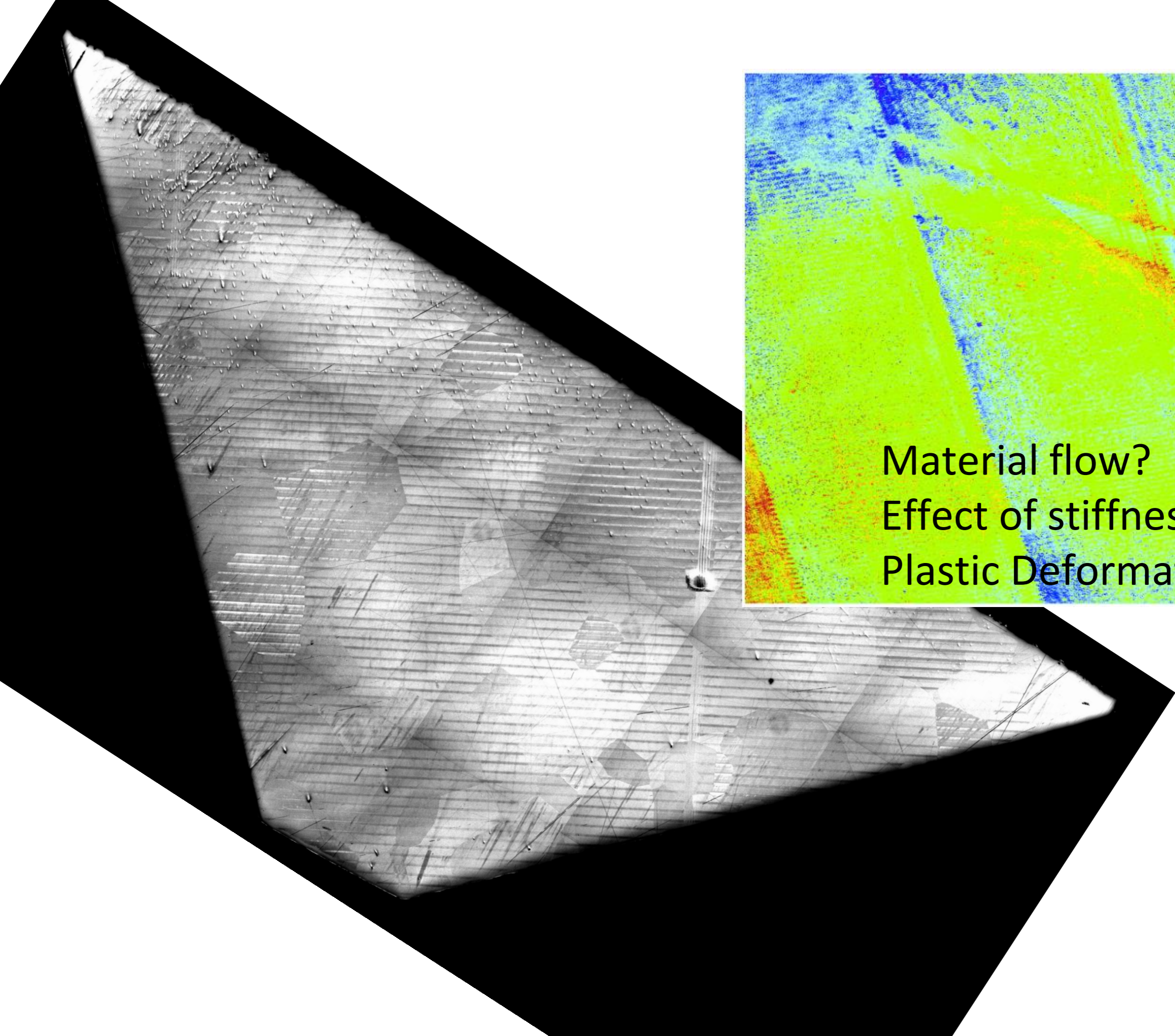


# What is left...in the long term

## Future possibilities

1. Rough surfaces - possibly even in the “as built” condition
2. Non planar (i.e., curved) surfaces
3. Non linear analysis paths (i.e., for MSA of electronic devices)
4. Improved resolution (a “quantum leap” to 1 $\mu$ m resolution?)
5. Time resolved experiments
6. Real-time determination (requires both a Gen-3 detector, laser upgrades, and clever databased approaches)





Material flow?  
Effect of stiffness?  
Plastic Deformation?

$\mu\text{m}$   
0.045  
0  
-0.048

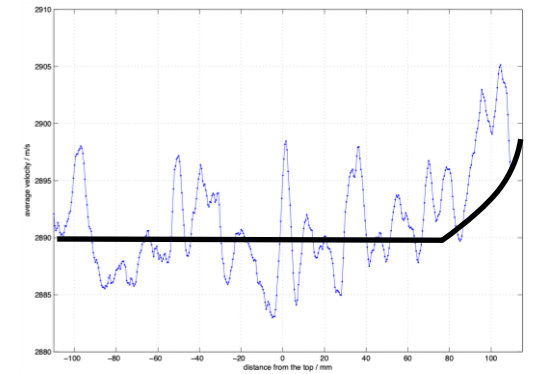
# Bottom Line: Possibilities and Limitations

## Possibilities:

Rapid orientation microscopy at large length scales ( $\text{dm}^2$ ) and in 3D ( $\text{cm}^2$ )

Time resolved experiments of dynamics

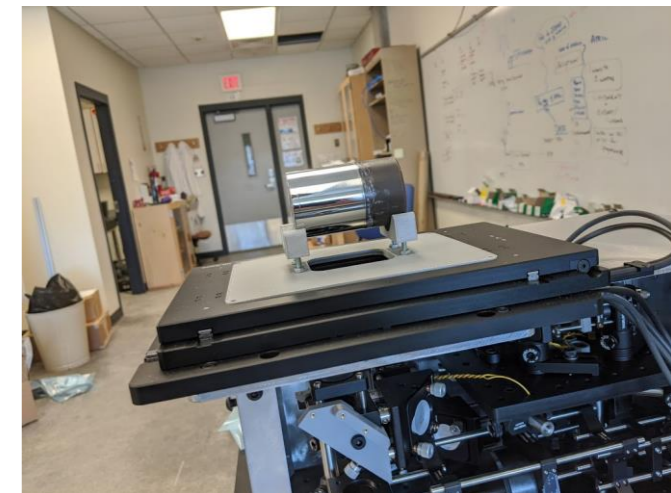
Measure/map any single variable that affects  $C_{ij}$  (including composition)



## Probabilities:

Orientation microscopy on rough surfaces (demonstrated in UK)

Orientation microscopy on curved surfaces (theoretically possible)



## Limitations:

No split photo diode with sufficient bandwidth (resolved for now)

Resolution (but a higher resolution should be possible)

Data and bandwidth is a challenge (but solvable)

Manufacturing infrastructure (resolving...but it takes time)

Sparsity in scientists

Multiple variables will convolve the signal



# Post-processing

Each pixel is represented as a 2500 point waveform.

Each row contains 200 px/mm.

With 0.1mm stepover, 2000px/mm<sup>2</sup>

20mm x 20mm scan contains 40k waveforms, or 200 million points.

Prototypical scan at 9 angles contains 28Gb of raw data.

# Post-process workflow

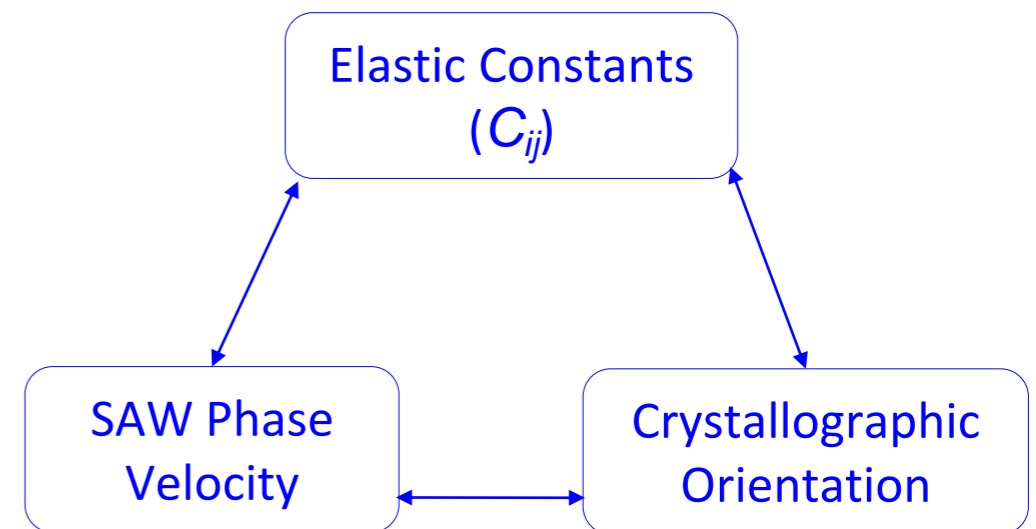
## The forward model:

Math says that if you have any two adjacent points on the triangle, you ***should*** be able to get the third.

This is a lie.

Brute Force the solution using a forward model. Then match results.

*Elastic constants, SAW Phase Velocity, and Crystallographic Orientation are interrelated.*

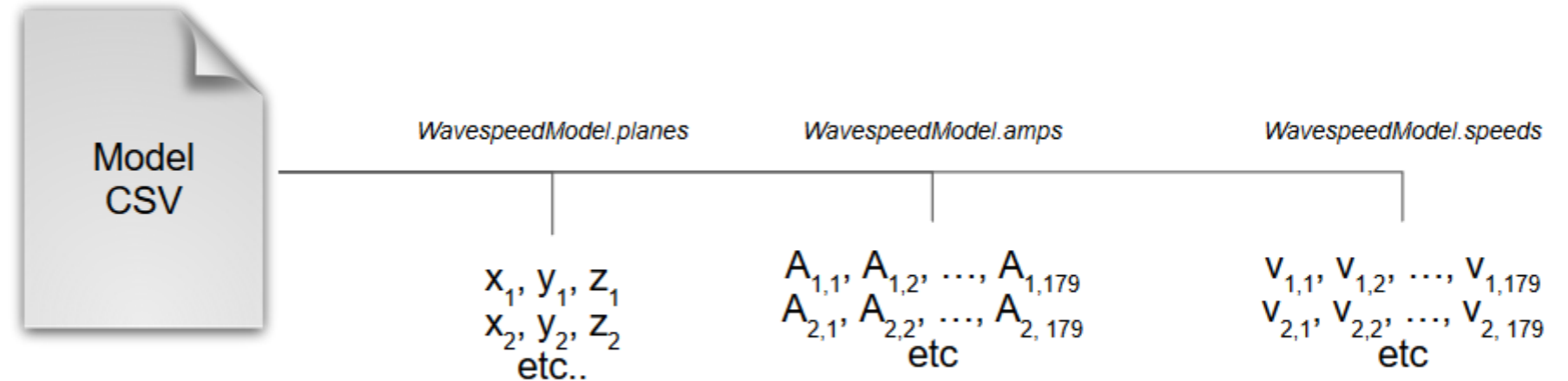


```

C:\Users\tka\source\repos\SRASForwardModel\SRASForwardModel\bin\Debug\SRASForwardModel.exe
TiA
C11=163.6, C12=92.3, C13=67.92, C14=0
C21=92.3, C22=163.6, C23=67.92, C24=0
C31=67.92, C32=67.92, C33=185.2, C34=0
C41=0, C42=0, C43=0, C44=47.05
Plane: [0 0 0.1, 0 / 970].
deg: 0
deg: 1
deg: 2
deg: 3
deg: 4
deg: 5
deg: 6
deg: 7
deg: 8
  
```

# Post-process workflow

## Now what?



Split the model CSV into a series of row-linked object properties for ease of lookup.

For every row:

For every pixel:

Extract experimentally acquired speeds at this pixel

Interpolate speeds between 0-180 and weight accordingly

For every plane in the model:

For 1\* shifts in the model:

Compare model v. experimental, assign fitness score

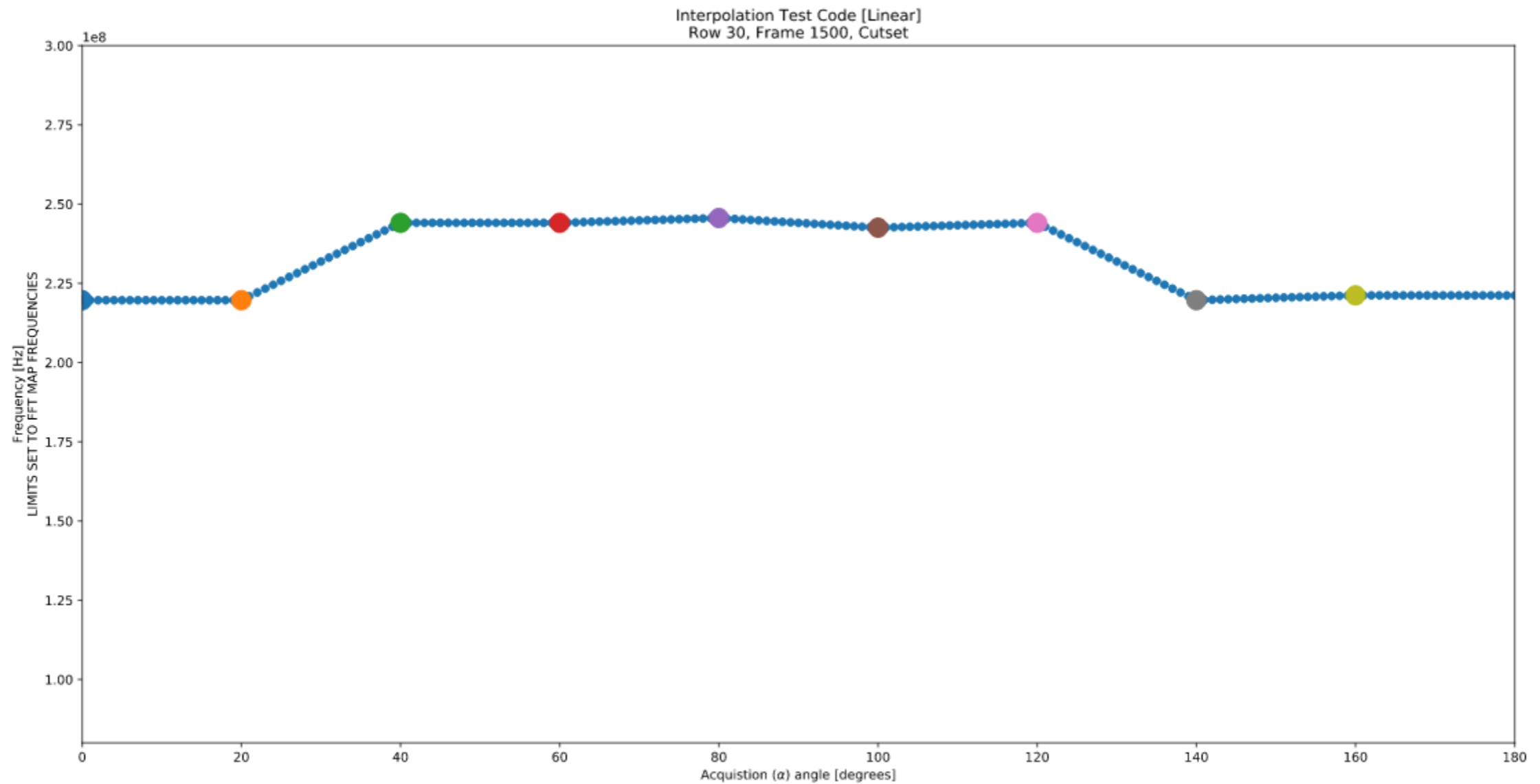
Choose highest score out of all planes + rotations and assign as plane normal.

Delta between model speed and required rotation is Phi

Repeat 80,000 times or so.



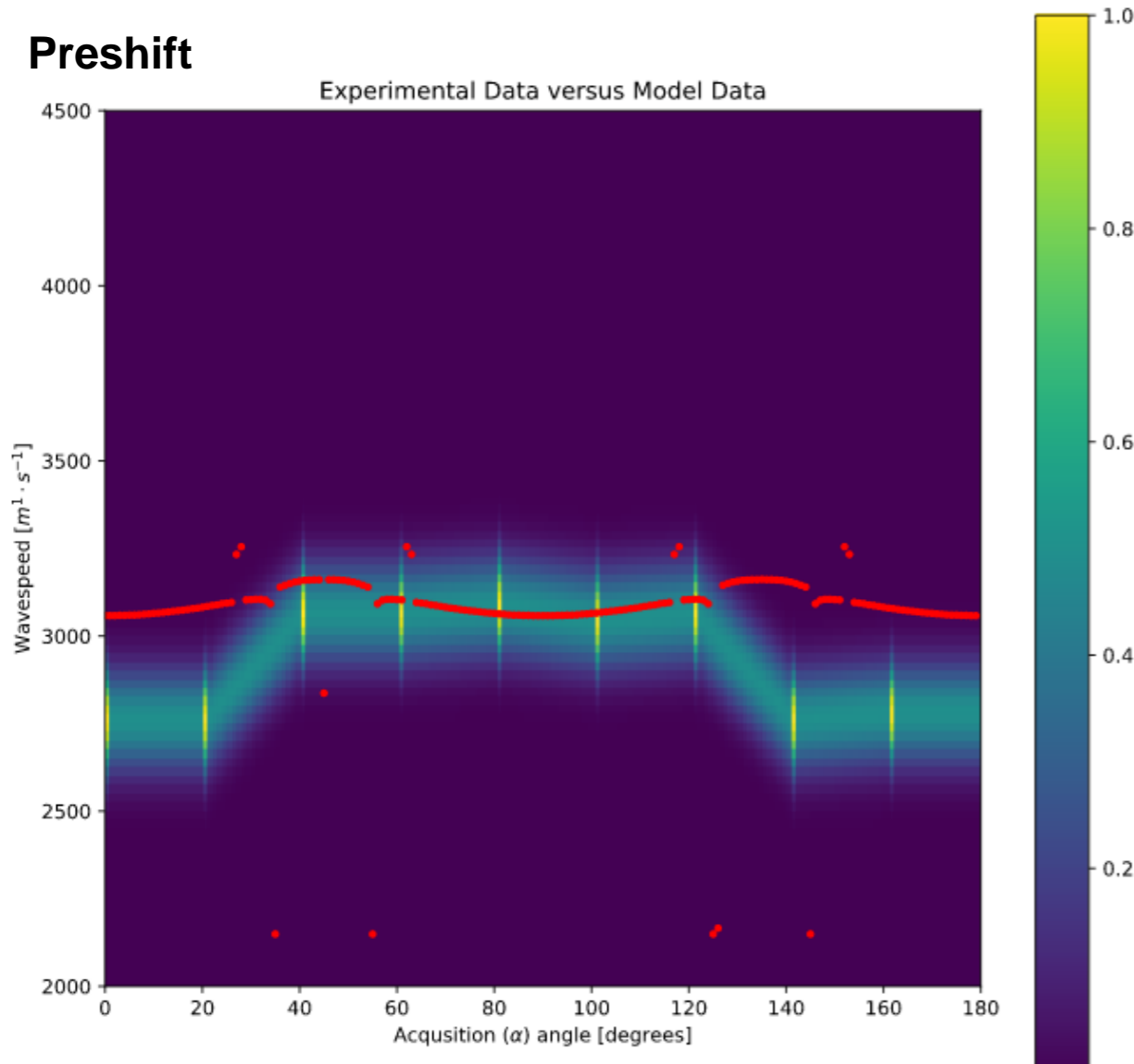
# Post-process workflow



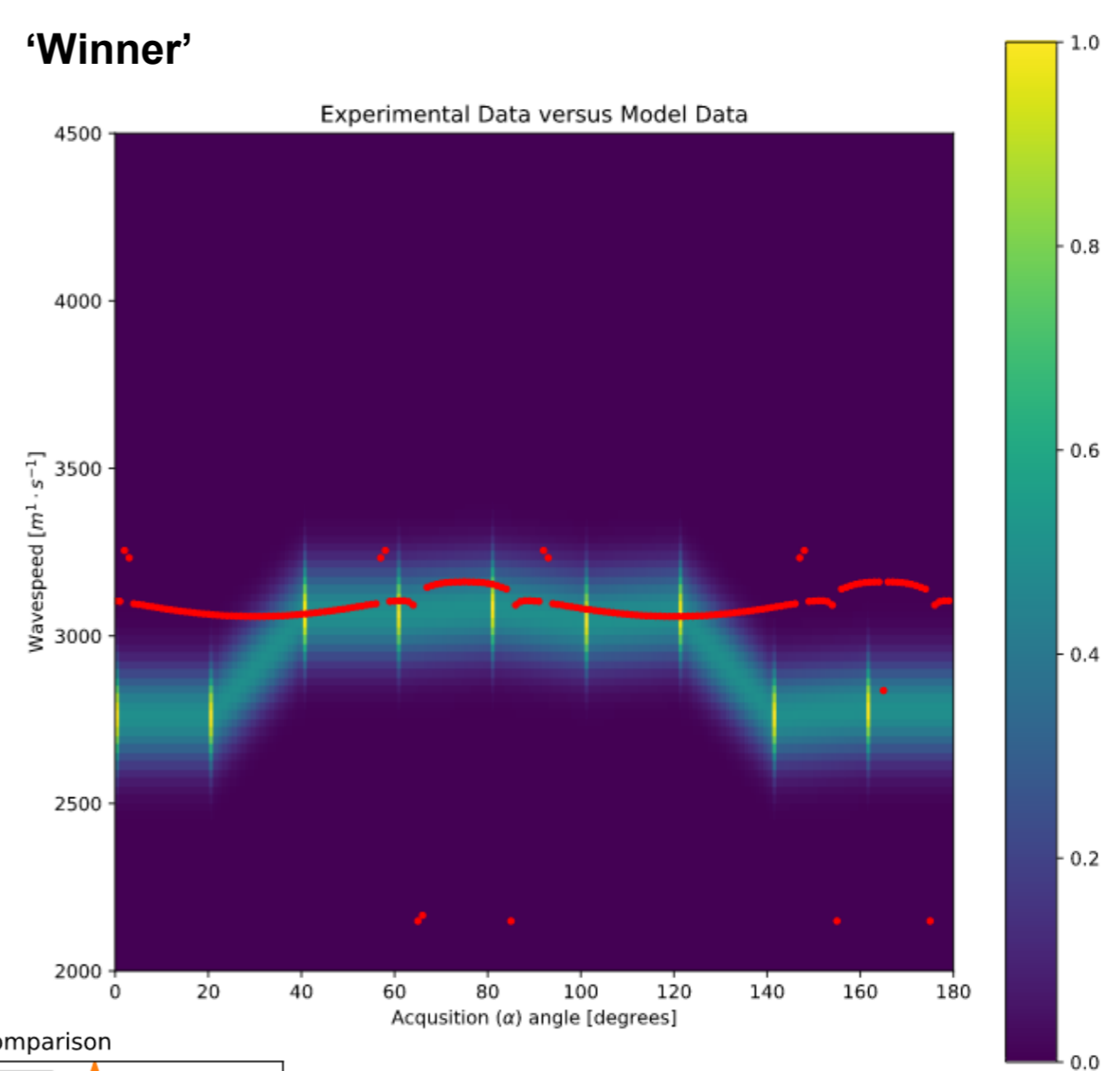
**Example of interpolated experimental frequency data**

# Post-process workflow

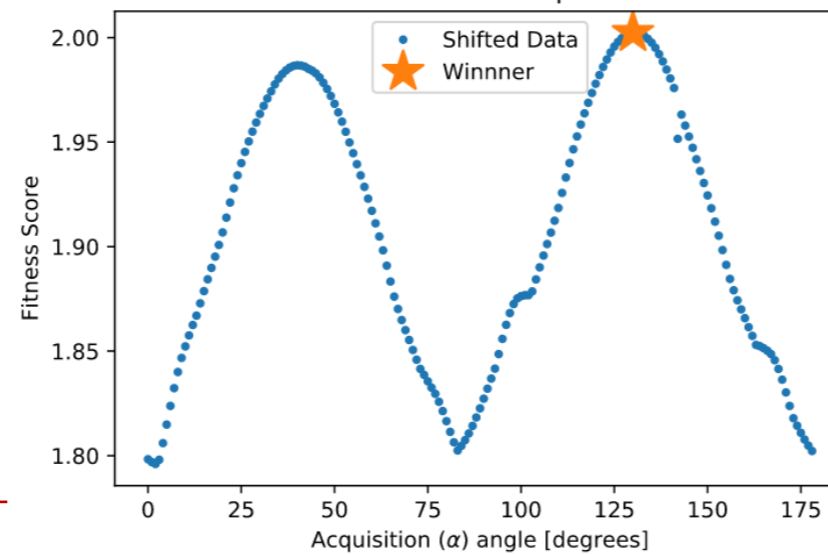
## Preshift



## 'Winner'



## Shifted Model Comparison



# If you ever visit Nottingham...

